SHARP ®

ID244H01

10MB Flash Memory Card

(Model No.: ID244H01)

Spec No.: EL108045

Issue Date: August 6, 1998

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● Please direct all queries regarding the products covered herein to a sales representative of the company.

SHARP

Contents

1. General Descriptions

The SHARP ID244H01, which panel design is SHARP standard, is a 10MB Flash Memory PC Card conforms to PCMCIA Release 2.0 and is offered to customers giving aim to confirm an external shape or electrical performances of the card. Before mass production, we will create a new product name dedicated for a customer and also present a specification which implies customer's request including panel design.

2. Features

| 2.1 | Type | 10MB Flash Memory Card |
| | | (Conforms to PCMCIA Rel.2.0) |

2.2   Memory Capacity
       Common Memory   10M words $\times$ 8 bits or 5M words $\times$ 16 bits
       Attribute Memory   EEPROM Model 2k words $\times$ 8 bits read/write

       Note) We have another type of attribute memory as follows.

               No EEPROM Model. (5 words $\times$ 8 bits read only in card's control circuit)

               Sample card name:ID244H02. Customers can choose one model from two.

2.3   Supply Voltage
       Read Cycle $V_{CC}=5\pm0.5V$, V_{PP1}, $V_{PP2}=0\sim1.5V$
       Read/Program/Erase Cycle $V_{CC}=5\pm0.5V$, V_{PP1}, $V_{PP2}=5.0V\pm0.5V/12.0V\pm0.6V$

2.4	Erase Unit	Block
		(64k bytes/byte access, 128k bytes/word access)
2.5	Program/Erase Cycles	100,000 cycles
2.6	Interface	Parallel I/O Interface
2.7	Function Table	See Function Table in page. 6
2.8	External Dimensions	54 $\times$ 85.6 $\times$ 3.3 mm
2.9	Pin Connections	See Pin Connections in page. 4
2.10	Type of Connector	Conforms to PCMCIA Rel.2.0 Card Use Connector
		(Card connector: JC20-J68S-NB3 JAE or FCN-568J068-G/0 Fujitsu
		or ICM-C68S-TS13-5035A JST)
2.11	Average Weight	30g
2.12	Operating Temp Range	0 to 60°C
2.13	Storage Temp Range	-20 to 65°C
2.14	External Appearance	External appearance shall be free of any dirt, cratches and abnormalities that could adversely affect sales.
2.15	Manufacturer's Code	The manufacturer's code shall be printed on the memory card directly or on the seal which is then attached to the memory card.
2.16	Brand Name	The user's brand name will be used.
2.17	Not designed or rated radiation hardened.	

3. Block Diagram
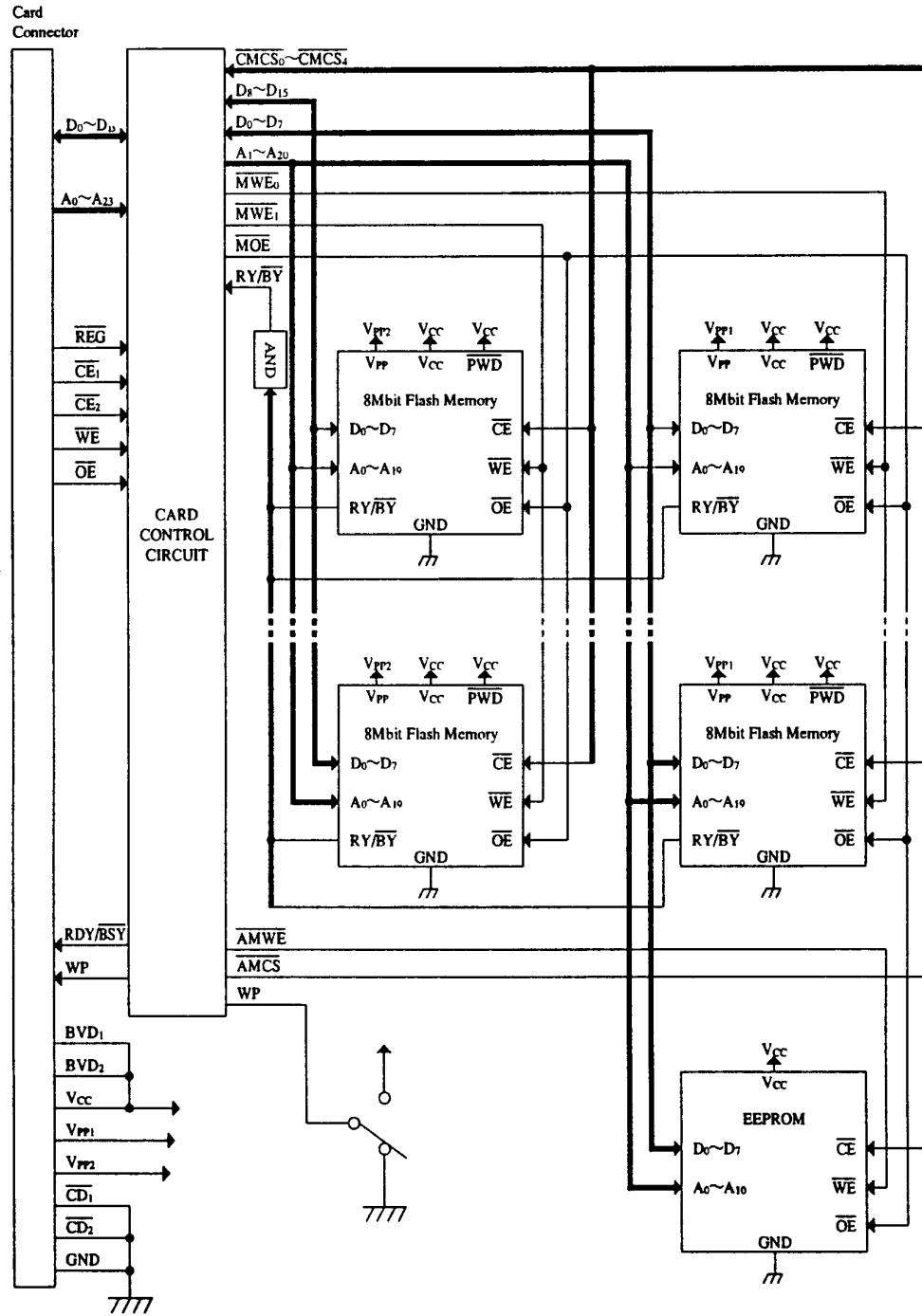
4. Pin Connections

PIN	SIGNAL	PIN	SIGNAL	PIN	SIGNAL	PIN	SIGNAL
1	GND	18	V_{PP1}	35	GND	52	V_{PP2}
2	D_3	19	A_{16}	36	$\overline{CD_1}$	53	A_{22}
3	D_4	20	A_{15}	37	D_{11}	54	A_{23}
4	D_5	21	A_{12}	38	D_{12}	55	A_{24}
5	D_6	22	A_7	39	D_{13}	56	A_{25} (NC)
6	D_7	23	A_6	40	D_{14}	57	NC
7	$\overline{CE_1}$	24	A_5	41	D_{15}	58	NC
8	A_{10}	25	A_4	42	$\overline{CE_2}$	59	NC
9	$\overline{OE}$	26	A_3	43	NC	60	NC
10	A_{11}	27	A_2	44	NC	61	$\overline{REG}$
11	A_9	28	A_1	45	NC	62	BVD_2
12	A_8	29	A_0	46	A_{17}	63	BVD_1
13	A_{13}	30	D_0	47	A_{18}	64	D_8
14	A_{14}	31	D_1	48	A_{19}	65	D_9
15	$\overline{WE/PGM}$	32	D_2	49	A_{20}	66	D_{10}
16	$RDY/\overline{BSY}$	33	WP	50	A_{21}	67	$\overline{CD_2}$
17	V_{CC}	34	GND	51	V_{CC}	68	GND

Pin Descriptions :

|	
$D_0 \sim D_7$	Data Bus (Input/output)
$D_8 \sim D_{15}$	Data Bus (Input/output)
$A_0 \sim A_{24}$	Address Bus (Input)
$\overline{CE_1}, \overline{CE_2}$	Card Enable (Input)
$\overline{OE}$	Output Enable (Input)
$\overline{WE/PGM}$	Write Enable/Program (Input)
$\overline{CD_1}, \overline{CD_2}$	Card Detect (Output) (Card Inserted Detection Signal)
WP	Write Protect (Output) (in write protect mode, the WP output signal is "HIGH")
V_{PP1}	Program/Erase Power Supply (Even Byte)
V_{PP2}	Program/Erase Power Supply (Odd Byte)
$\overline{REG}$	Register Select (Input)
BVD_1, BVD_2	Battery Voltage Detect (Always "HIGH")
$RDY/\overline{BSY}$	Ready/Busy (Output)

5. Function

5.1 Memory Block

5.1.1 Memory Configuration   8Mbits Flash Memory×10 Devices.

5.1.2 Memory Erase Unit   Block Erase

Block：   Byte Mode   64k bytes

Word Mode   128k bytes

Block Pair
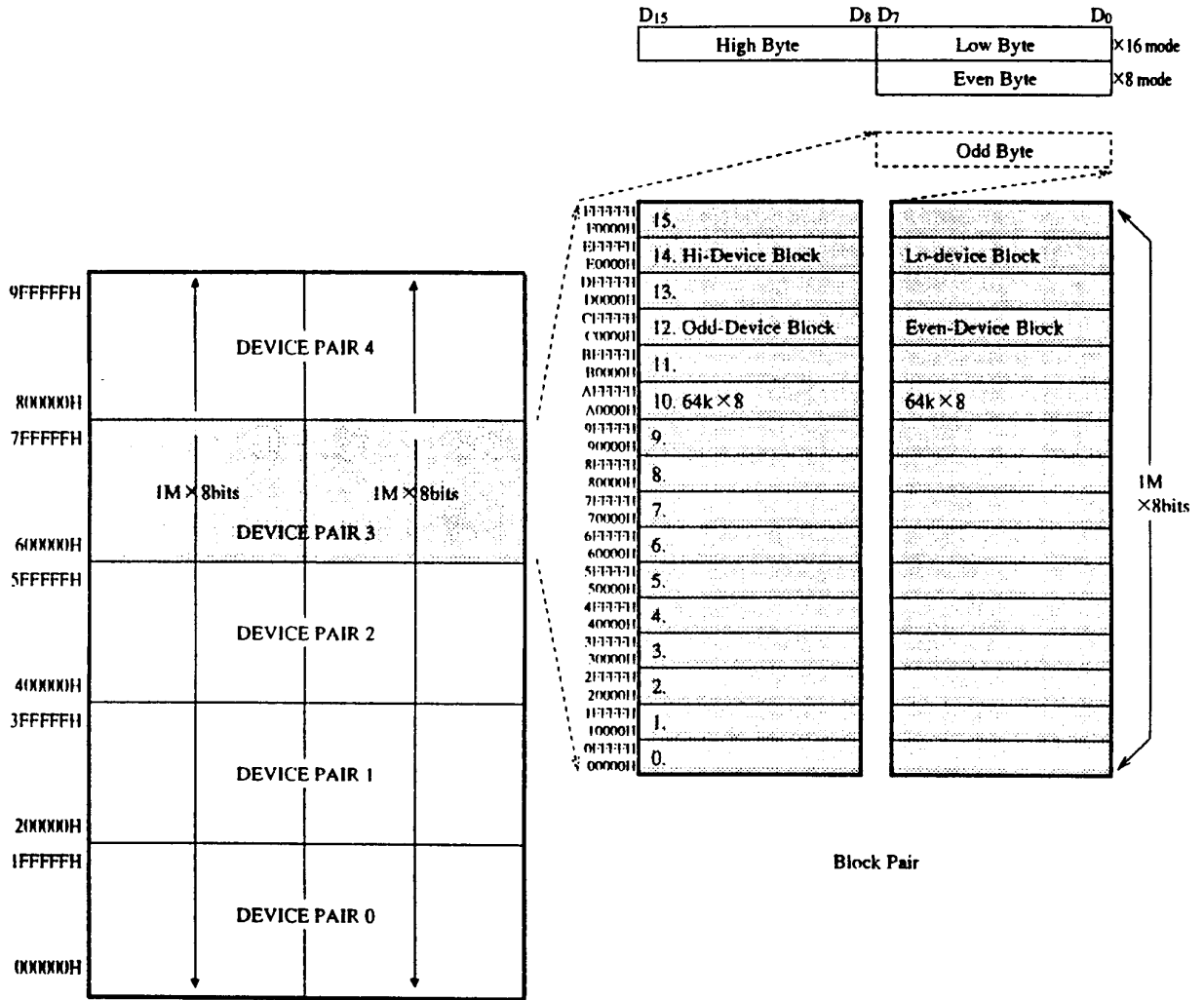
5.2 Function Table

$\overline{CE_1}$	$\overline{CE_2}$	A_0	$\overline{WE}$	$\overline{OE}$	$\overline{REG}$	V_{PP1}	V_{PP2}	V_{CC}	Operation	D_0-D_7	D_8-D_{15}	Status
H	H	×	×	×	H	V_{PPL}	V_{PPL}	V_{CC}		Hi-Z	Hi-Z	Standby
L	H	L	H	L	H	V_{PPL}	V_{PPL}	V_{CC}	Read (×8)	Do (Even)	Hi-Z	Byte
L	H	H	H	L	H	V_{PPL}	V_{PPL}	V_{CC}	Read (×8)	Do (Odd)	Hi-Z	Byte
L	L	×	H	L	H	V_{PPL}	V_{PPL}	V_{CC}	Read (×16)	Do (Even)	Do (Odd)	Word
H	L	×	H	L	H	V_{PPL}	V_{PPL}	V_{CC}	Read (×8)	Hi-Z	Do (Odd)	Byte
L	×	×	×	H	H	V_{PPL}	V_{PPL}	V_{CC}	Outpu Disable	Hi-Z	Hi-Z	Byte
H	L	×	×	H	H	V_{PPL}	V_{PPL}	V_{CC}	Outpu Disable	Hi-Z	Hi-Z	Byte
L	H	L	L	H	H	V_{PPH}	V_{PPX}	V_{CC}	Program (×8)	Di (Even)	Don't care	Byte
L	H	H	L	H	H	V_{PPX}	V_{PPH}	V_{CC}	Program (×8)	Di (Odd)	Don't care	Byte
L	L	×	L	H	H	V_{PPH}	V_{PPH}	V_{CC}	Program (×16)	Di (Even)	Di (Odd)	Word
H	L	×	L	H	H	V_{PPX}	V_{PPH}	V_{CC}	Program (×8)	Don't care	Di (Odd)	Byte
L	H	L	H	L	H	V_{PPH}	V_{PPX}	V_{CC}	Verify (×8)	Do (Even)	Hi-Z	Byte
L	H	H	H	L	H	V_{PPX}	V_{PPH}	V_{CC}	Verify (×8)	Do (Odd)	Hi-Z	Byte
L	L	×	H	L	H	V_{PPH}	V_{PPH}	V_{CC}	Verify (×16)	Do (Even)	Do (Odd)	Word
H	L	×	H	L	H	V_{PPX}	V_{PPH}	V_{CC}	Verify (×8)	Hi-Z	Do (Odd)	Byte
L	H	H	L	L	H	V_{PPH}	V_{PPX}	V_{CC}	*1 Prohibited	—	—	—
L	H	L	L	L	H	V_{PPX}	V_{PPH}	V_{CC}	*1 Prohibited	—	—	—
L	L	×	L	L	H	V_{PPH}	V_{PPH}	V_{CC}	*1 Prohibited	—	—	—
H	L	×	L	L	H	V_{PPX}	V_{PPH}	V_{CC}	*1 Prohibited	—	—	—

*1.　Do not use this mode as it will result in write errors.

H	: High	L	: Low	×	: Don't Care
Di	: Input Data	Do	: Output Data	Hi-Z	: High Impedance
V_{CC}	: 4.5 ~ 5.5V	V_{PPL}	: 0.0 ~ 1.5V	V_{PPH}	: 4.5 ~ 5.5V/11.4 ~ 12.6V
V_{PPX}	: V_{PPL} or V_{PPH}				

Caution: When the write Protect switch is in protect-mode, the WP signal is "HIGH" and write operation are not allowed.

5.3 Software Command (8/16 Bits Operation ( ) : 16 Bits Operation)

Command	Bus Cycles	First Bus Cycle			Second Bus Cycle			
		Operation	Address	Data	Operation	Address	Data Input	Data Output
Read Array/Reset	1	Write	RA	FFH/ (FFFFH)	—	—	—	—
Read Intelligent Identifier	3	Write	DA	90H/ (9090H)	Read	IA	—	IID
Read Status Register	2	Write	DA	70H/ (7070H)	Read	DA	—	SRD
Clear Status Register	1	Write	DA	50H/ (5050H)	—	—	—	—
Erase Setup/Erase Confirm	2	Write	BA	20H/ (2020H)	Write	BA	D0H/ (D0D0H)	—
Erase Suspend/Erase Resume	2	Write	BA	B0H/ (B0B0H)	Write	BA	D0H/ (D0D0H)	—
Byte Write Setup/Write	2	Write	WA	40H/ (4040H)	Write	WA	WD	—
Alternate Byte Write Setup/Write	2	Write	WA	10H/ (1010H)	Write	WA	WD	—

Note) 1. This Table shows the basic from of Erase, Verify and Program Verify.

Refer Programming Flowchart, Erase Algorithm in detail.

2. Bus operations are defined in function table in page.

3. IA : Device Identifier Address   IID : Device Identifier Data

	DA	IA			IID	
		8Bits (Even Device)	8Bits (Odd Device)	16Bits	Byte (8Bits)	Word (16Bits)
Manufacturer Code	000000H~1FFFFFH	000000H	000001H	000000H	89H	8989H
Device Code	000000H~1FFFFFH	000002H	000003H	000001H	A6H	A6A6H

RA : Read Address   WA : Write Address   WD : Write Data

DA : Device Address (Any Address in device is acceptable.)

BA : Erase Block Address (Erase Size is 64k Bytes.)

SRD : Status Register Data

4. Either 40H (4040H) or 10H (1010H) are recognized by the WSM as the Byte Write Setup Command.

a) Read Array/Reset Command : (FFH/FFFFH)

By writing this command, device. Devices pair become read mode. The device remains enable for reads until the Command User Interface contents are altered.

b) Intelligent Identifier Command : (90H/9090H) :

After writing this command into the Command User Interface, a read cycle retrieves the manufacturer Code and device Code. To terminate the Operation, it is necessary to write another valid command into the register.

c) Read Status Register Command : (70H/7070H) :

By Writing this command, the Status Register may be read at any time to determine when a byte or block erase operation is complete, and whether that operation completed successfully.

Refer to Status Register definition in page. 9. After writing this command, all subsequent read operations output data from the Status Register, until another valid command is written to the Command User Interface.

d) Clear Status Register Command : (50H/5050H)

Status bits which show error, the Erase Status (SR. 5), Byte Write Status (SR. 4) bits and the V_{PP} Status bit (SR. 3) can be reset by the Clear Status Machine Register Command.

e) Erase Setup/Erase Command : (20H/2020H) (D0H/D0D0H) : Erase is executed one block (64kB for 1 device, 128kB for 2 devices) at a time.

This command is functional when $V_{PP} = V_{PPH}$ and an Erase Setup Command is first written to the Command User Interface, followed by the Erase Confirm Command. After that, the device automatically outputs Status Register data when read.

The CPU can detect the completion of the erase event by analyzing the output of the RDY/$\overline{BSY}$ pin, or the WSM Status bit of the Status Register. When erase is completed, the Erase Status bit should be checked. If erase error is detected, the Status Register should be cleared.

f) Erase Supend/Erase Resume Command : (B0H/B0B0H) / (D0H/D0D0H)

The Erase Suspend command allows block erase interruption in order to read data from another block of memory. The device continues to output Status Register data when read, after the Erase Suspend Command is written. Polling the WSM Status and Erase Suspend Status bits will determine when the erase operation has been suspended. RDY/$\overline{BSY}$ pin will also transition to V_{OH}. At this point, a Read Array Command can be written to the Command User Interface to read data from blocks other than that which is suspended. V_{PP} must remain at V_{PPH} while device is in Erase Suspend.

Erase Resume Command, at which time the WSM will continue with the erase process. The Erase Suspend Status and WSM Status bits of the Status Register will be automatically cleared and RDY/$\overline{BSY}$ pin will return to V_{OL}. After the Erase Resume is written, the device automatically output Status Register data when read.

g) Byte Write Setup/Write Command : (40H/4040H) or (10H/1010H)

This command is functional when $V_{PP} = V_{PPH}$ and an Byte Write Setup Command is first written to the Command User Interface, followed by a second write specifying the address and data to be written. The WSM then take over, controlling the byte write and write verify algorithms internally. After the two command byte sequence is written to it, the device automatically outputs Status Register data when read. The CPU can detect the completion of the byte write event by analyzing the output of the RDY/$\overline{BSY}$ pin, or the WSM Status bits of the Status Register.

5.4 Status Register

The memory devices in this card have Status Register which shows state of the device.

Byte Access × 8 Bits

bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0
SR.7	SR.6	SR.5	SR.4	SR.3	SR.2	SR.1	SR.0
WSMS	ESS	ES	BWS	VPPS	RFU	RFU	RFU

Register	Contents
SR.7＝Write State Machine Status 　1＝Ready 　0＝Busy	When set "1" s, read, erase, data write is acceptable.
SR.6＝Erase Suspend Status 　1＝Erase Suspend 　0＝Erase In Progress/Completed	Check whether Erase Suspend Command is executed or not.
SR.5＝Erase Status 　1＝Error In Block Erase 　0＝Successful Block Erase	Set "1" s when fail to Erase. Reset by the Clear Status Register Command.
SR.4＝Byte Write Status 　1＝Error In Byte Write 　0＝Successful Byte Write	Set "1" s when fail to Byte Write. Reset by the Clear Status Register Command.
SR.3＝V_{PP} Status 　1＝V_{PP} Low Detect ; Operation Abort 　0＝V_{PP} OK	Set "1" s when V_{PP}, which is needed in Byte Write or Erase operation, is below V_{PPH}. Reset by the Clear Status Register Command.
SR.2～SR.0＝Reserved for Future Use	

Word Access × 16 bits

bit15							bit8	bit7							bit0
SR.15	SR.14	SR.13	SR.12	SR.11	SR.10	SR.9	SR.8	SR.7	SR.6	SR.5	SR.4	SR.3	SR.2	SR.1	SR.0

Odd Byte device   Even Byte device

5.5 Programming Flowchart

(Byte Mode)
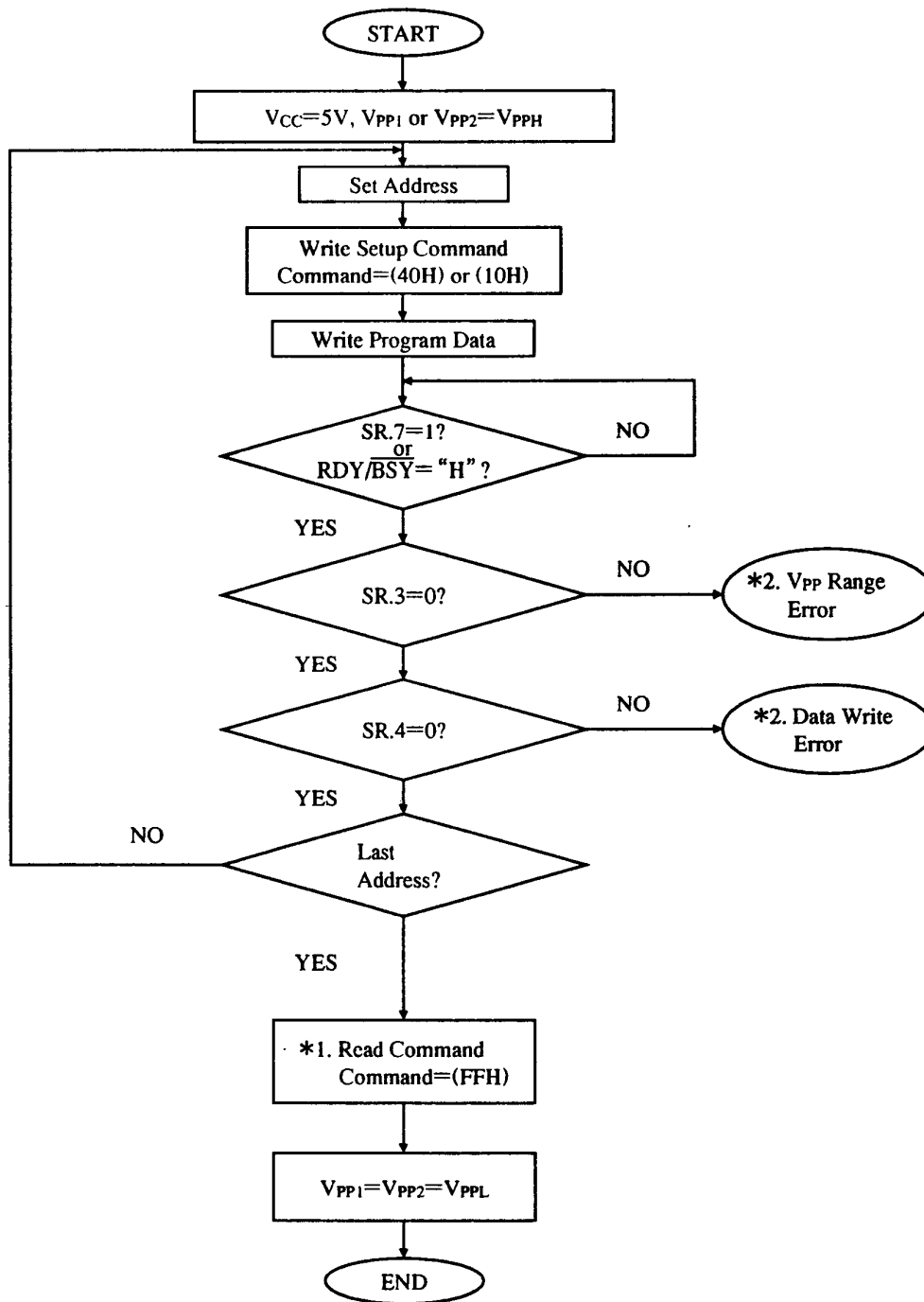
```
                        ┌─────────┐
                        │  START  │
                        └────┬────┘
                             │
          ┌──────────────────┴──────────────────┐
          │  Vcc=5V, Vpp1 or Vpp2=Vpph          │
          └──────────────────┬──────────────────┘
                             │
                    ┌────────┴────────┐
                    │   Set Address   │
                    └────────┬────────┘
                             │
              ┌──────────────┴──────────────┐
              │  Write Setup Command        │
              │  Command=(40H) or (10H)     │
              └──────────────┬──────────────┘
                             │
                 ┌───────────┴───────────┐
                 │  Write Program Data    │
                 └───────────┬───────────┘
                             │
                       ◇ SR.7=1?              NO
                       ◇  or        ─────────────►
                       ◇ RDY/BSY="H"?
                             │ YES
                       ◇ SR.3=0?    NO   ►  *2. Vpp Range Error
                             │ YES
                       ◇ SR.4=0?    NO   ►  *2. Data Write Error
                             │ YES
              NO     ◇ Last Address?
              ◄──────
                             │ YES
                 ┌───────────┴───────────┐
                 │ *1. Read Command       │
                 │    Command=(FFH)       │
                 └───────────┬───────────┘
                             │
                 ┌───────────┴───────────┐
                 │  Vpp1=Vpp2=Vppl        │
                 └───────────┬───────────┘
                             │
                        ┌────┴────┐
                        │   END   │
                        └─────────┘
```

Note) * 1. Write FFH after the last block write operation to reset the device to Read Array Mode.

* 2. If error is detected, clear the Status Register before attempting retry or other error recovery.

Programming Flowchart

(Word Mode)

START

Vcc=5V, Vpp1=Vpp2=VPPH

Set Address

Y=0

Write Setup Command
Y=0 : Command=4040H or 1010H
Y=1 : Command=FF40H or FF10H
Y=2 : Command=40FFH or 10FFH

Write Program Data
Y=0 : Program Data=PDPDH
Y=1 : Program Data=FFPDH
Y=2 : Program Data=PDFFH

SR.7=1?
and
SR.15=1?
or
RDY/BSY="H"?

NO

YES

SR.3=0?
and
SR.11=0?

NO → *2. Vpp Range Error

YES

SR.4=0?
and
SR.12=0?

NO → *2. Data Write Error

YES

Last Address?

NO

YES

*1. Read Command
Command=(FFFFH)

Vpp1=Vpp2=VppL

END

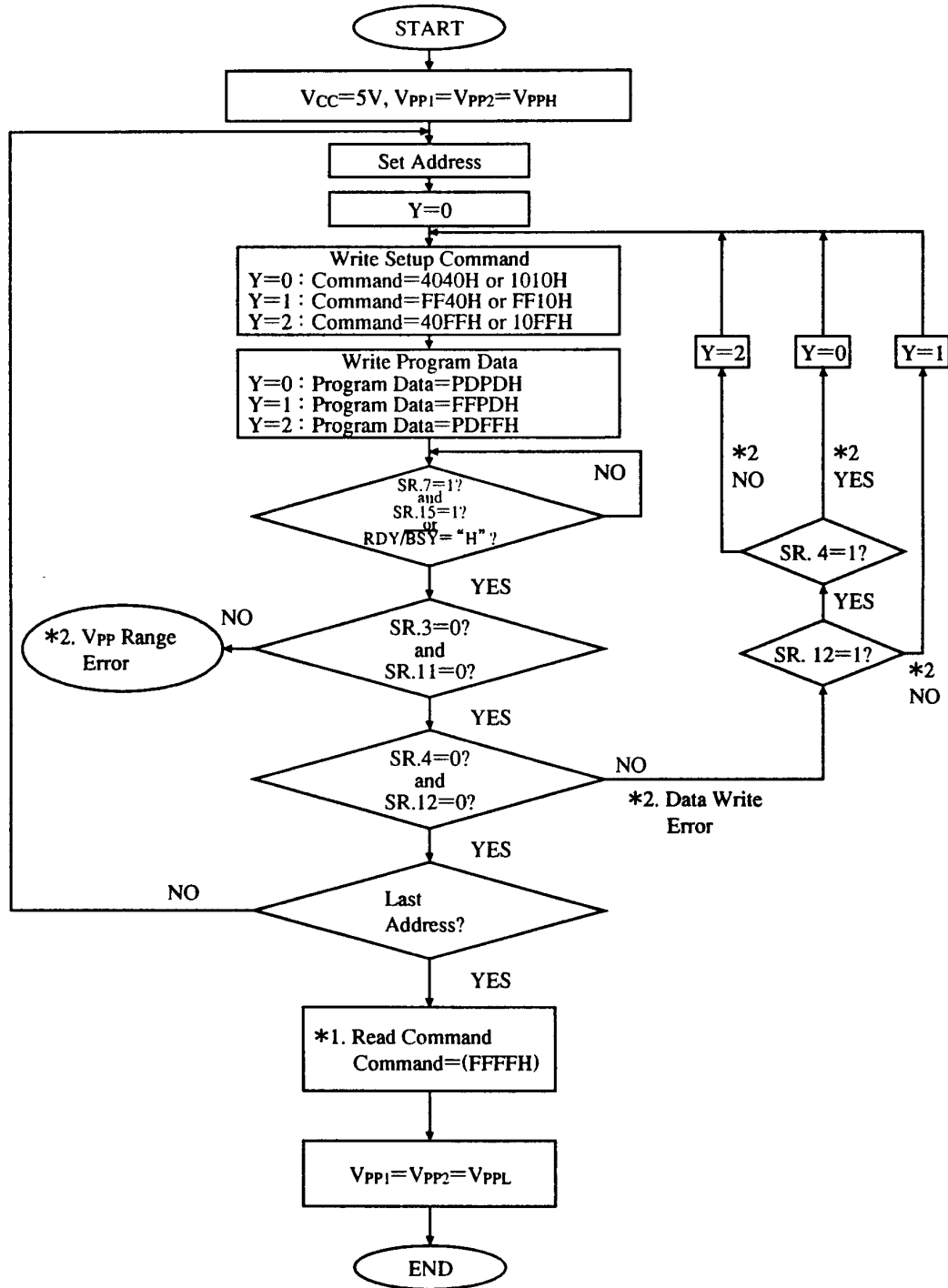Y=2   Y=0   Y=1

*2 NO   *2 YES

SR. 4=1?

YES

SR. 12=1?   *2 NO

Note) * 1. Write FFFFH after the last block write operation to reset the device to Read Array Mode.

* 2. If error is detected, clear the Status Register before attempting retry or other error recovery.
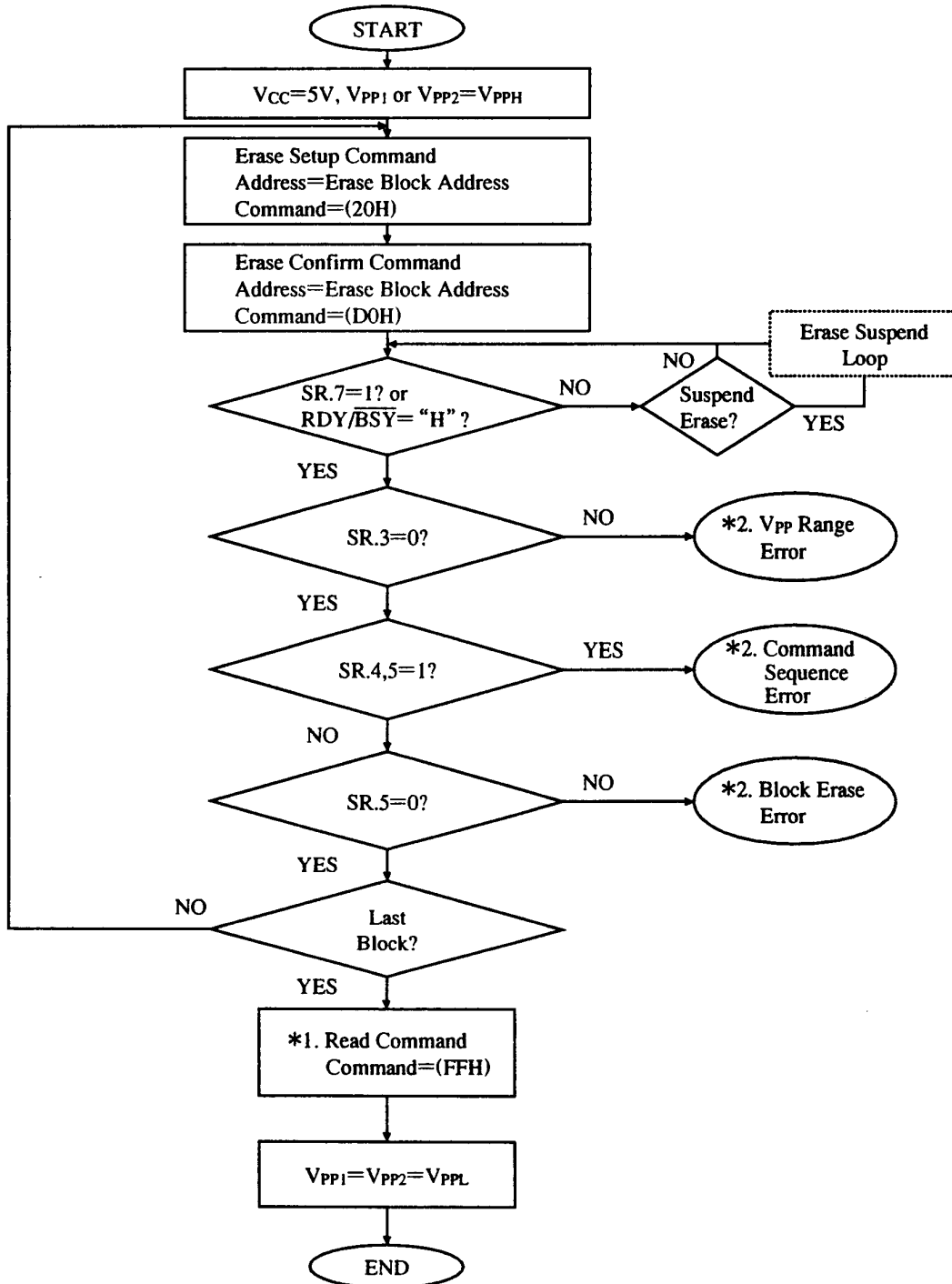
5.6 Erase Algorithm

(Byte Mode)

```
                            ┌─────────┐
                            │  START  │
                            └─────────┘
                                 │
            ┌────────────────────────────────────────┐
            │  Vcc=5V, Vpp1 or Vpp2=VppH             │
            └────────────────────────────────────────┘
                                 │
    ┌─────────────────────────────────────────────────┐
    │  Erase Setup Command                            │
    │  Address=Erase Block Address                    │
    │  Command=(20H)                                  │
    └─────────────────────────────────────────────────┘
                                 │
    ┌─────────────────────────────────────────────────┐
    │  Erase Confirm Command                          │
    │  Address=Erase Block Address                    │
    │  Command=(D0H)                                  │         ┌──────────────┐
    └─────────────────────────────────────────────────┘         │ Erase Suspend│
                                 │                    NO         │     Loop     │
                    ◇ SR.7=1? or ──────────  ◇ Suspend ───────── └──────────────┘
                      RDY/BSY="H"?    NO       Erase?    YES
                                 │ YES
                                 │
                    ◇ SR.3=0? ────────── ( *2. Vpp Range Error )
                                 │   NO
                                 │ YES
                    ◇ SR.4,5=1? ────────── ( *2. Command Sequence Error )
                                 │   YES
                                 │ NO
                    ◇ SR.5=0? ────────── ( *2. Block Erase Error )
                                 │   NO
                                 │ YES
         NO         ◇ Last Block?
      ──────────
                                 │ YES
    ┌─────────────────────────────────────────────────┐
    │  *1. Read Command                               │
    │      Command=(FFH)                              │
    └─────────────────────────────────────────────────┘
                                 │
    ┌─────────────────────────────────────────────────┐
    │  Vpp1=Vpp2=VppL                                 │
    └─────────────────────────────────────────────────┘
                                 │
                            ┌─────────┐
                            │   END   │
                            └─────────┘
```

Note) *1. Write FFH after the last block write operation to reset the device to Read Array Mode.

　　　　*2. If error is detected, clear the Status Register before attempting retry or other error recovery.
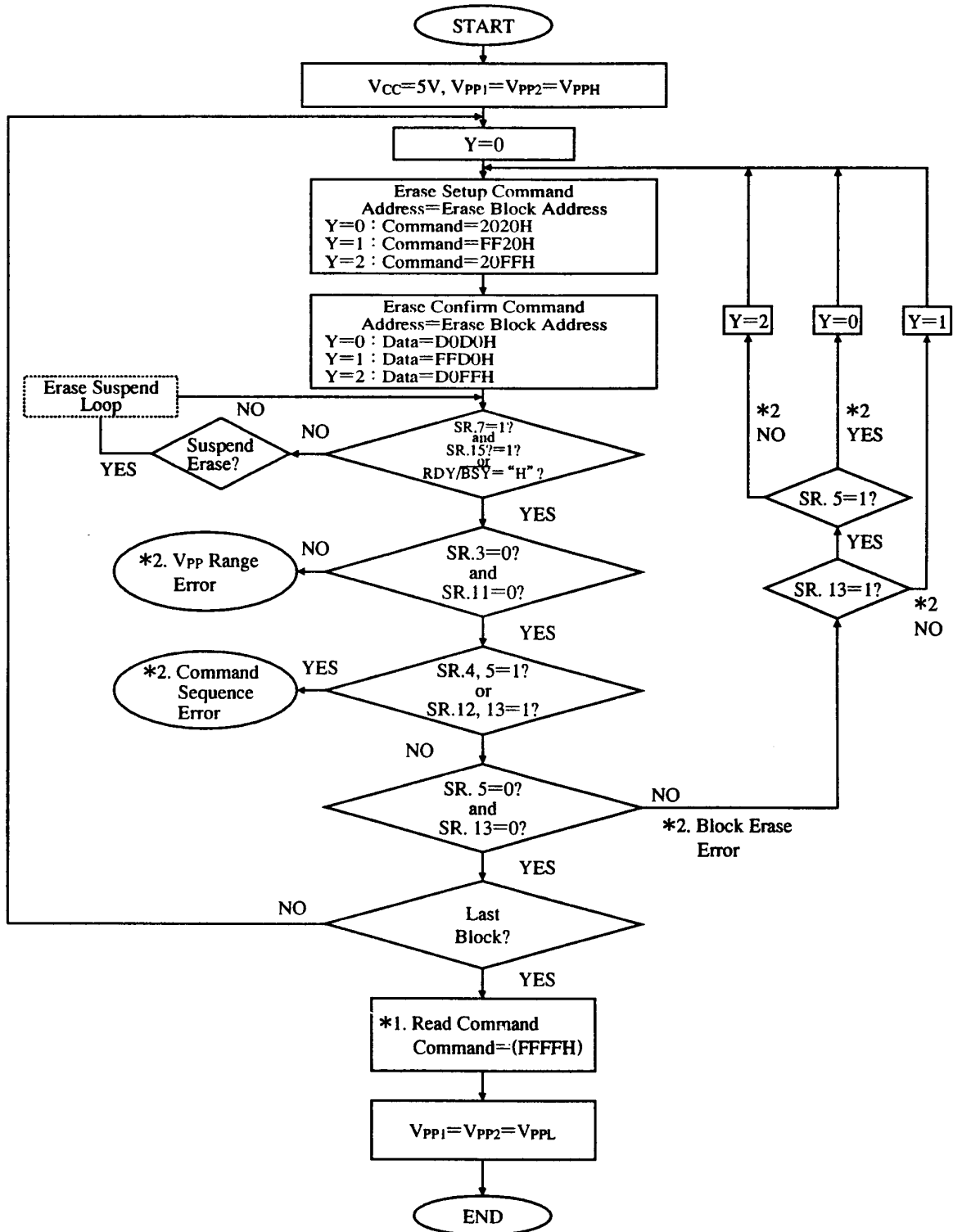
Erase Algorithm

(Word Mode)

START

$V_{CC}=5V$, $V_{PP1}=V_{PP2}=V_{PPH}$

Y=0

Erase Setup Command
Address=Erase Block Address
Y=0 : Command=2020H
Y=1 : Command=FF20H
Y=2 : Command=20FFH

Erase Confirm Command
Address=Erase Block Address
Y=0 : Data=D0D0H
Y=1 : Data=FFD0H
Y=2 : Data=D0FFH

Erase Suspend Loop

Suspend Erase?

SR.7=1?
and
SR.15?=1?
or
RDY/BSY="H"?

NO

NO

YES

YES

SR.3=0?
and
SR.11=0?

NO → *2. Vpp Range Error

YES

SR.4, 5=1?
or
SR.12, 13=1?

YES → *2. Command Sequence Error

NO

SR. 5=0?
and
SR. 13=0?

NO

YES

Last Block?

NO

YES

*1. Read Command
Command=(FFFFH)

$V_{PP1}=V_{PP2}=V_{PPL}$

END

Y=2   Y=0   Y=1

*2 NO   *2 YES

SR. 5=1?

YES

SR. 13=1?

*2 NO

*2. Block Erase Error

Note) * 1. Write FFFFH after the last block erase operation to reset the device to Read Array Mode.

* 2. If error is detected, clear the Status Register before attempting retry or other error recovery.

6. Absolute Maximum Ratings

PARAMETER	SYMBOL	RATING	UNIT
Supply Voltage	V_{CC}	-0.3 to 7.0	V
Input Voltage	V_{IN}	-0.3 to $V_{CC}+0.3$ (Max : 7.0)	V
Output Voltage	V_{OUT}	-0.3 to $V_{CC}+0.3$ (Max : 7.0)	V
Operating Temperature	T_{OPR}	0 to $+60$	℃
Storage Temperature	T_{STG}	-20 to $+65$	℃

7. Recommended Operating Conditions

PARAMETER	SYMBOL	Min.	Max.	UNIT
Operating Temperature	T_{OPR}	0	$+60$	℃
Supply Voltage	V_{CC}	4.5	5.5	V
Input Voltage High	V_{IH}	3.5	$V_{CC}+0.3$	V
Input Voltage Low	V_{IL}	-0.3	1.5	V

8. Capacitance

PARAMETER	SYMBOL	Min.	TYP	Max.	UNIT	CONDITION
Input Capacitance	C_{IN}	—	17	—	pF	$V_{CC}=5V\pm10\%$
Input/Output Capacitance	C_{IO}	—	17	—	pF	$f=1MHz$, $Ta=25℃$

9. Read Operation

9.1 DC Characteristics

$(V_{CC}=4.5\sim5.5V, Ta=0\sim60°C)$

PARAMETER		SYMBOL	Min.	TYP	Max.	UNIT	CONDITION
Operating Voltage	High Temperature	V_{CC}	4.5	—	5.5	V	
	Low Temperature						
Current Consumption *1	Static Operatin Current	I_{SB}	—	—	2.0	mA	X16, Address : PingPong
	Dynamic Operating Current	I_{CC}	—	—	80		
Input Voltage	Input Voltage Level High	V_{IH}	3.5	—	$V_{CC}+0.3$	V	$V_{CC}=4.5\sim5.5V$
	Input Voltage Level Low	V_{IL}	-0.3	—	1.5		
Input Current	$A_0\sim A_{23}, D_0\sim D_{15}$	I_{LI}	-10		70	μA	$V_1=V_{CC}, 0V$
	$\overline{CE_1}, \overline{CE_2}, \overline{OE}, \overline{WE}, \overline{REG}$		-70	—	10		
Output Voltage	High	V_{OH}	$V_{CC}\sim0.5$	—	—	V	$I_{OH}=-2mA$ (*2) $I_{OH}=-4\mu A$ (*3)
	Low	V_{OL}	—	—	0.4		$I_{OL}=4mA$

PingPong : Scan the target address, with accessing the target and another address alternately.

*1   (1) Static Operating Current : With the memory card's voltage at 5.5V and the $\overline{CE_1}, \overline{CE_2}, \overline{OE}, \overline{WE}$ and $\overline{REG}$ signals "HIGH" ($V_{IH}=V_{CC}-0.2V$), A_0 signal "LOW" ($V_{IL}\leqq0.2V$) the current consumption is measured with the output open.

      (2) Dynamic Operating Current : With the memory card's V_{CC} at 5.5V and $V_{PP1}=V_{PP2}$ at 12.6V, current consumption during access is measured with the output open. (Access time : 200ns) The current depends on addressing.

*2 $D_0\sim D_{15}$

*3 $BVD_1, BVD_2, RDY/\overline{BSY}, WP$

9.2 AC Characteristics ($V_{CC}=4.5\sim5.5V, V_{PP}=0.0\sim1.5V, Ta=0\sim60°C$)

Testing Conditions:

   1) Input Pulse Level   : 0.8~3.5V

   2) Input Rise/Fall Time   : 10ns

   3) Input/Output Timing Reference Level : 1.5V

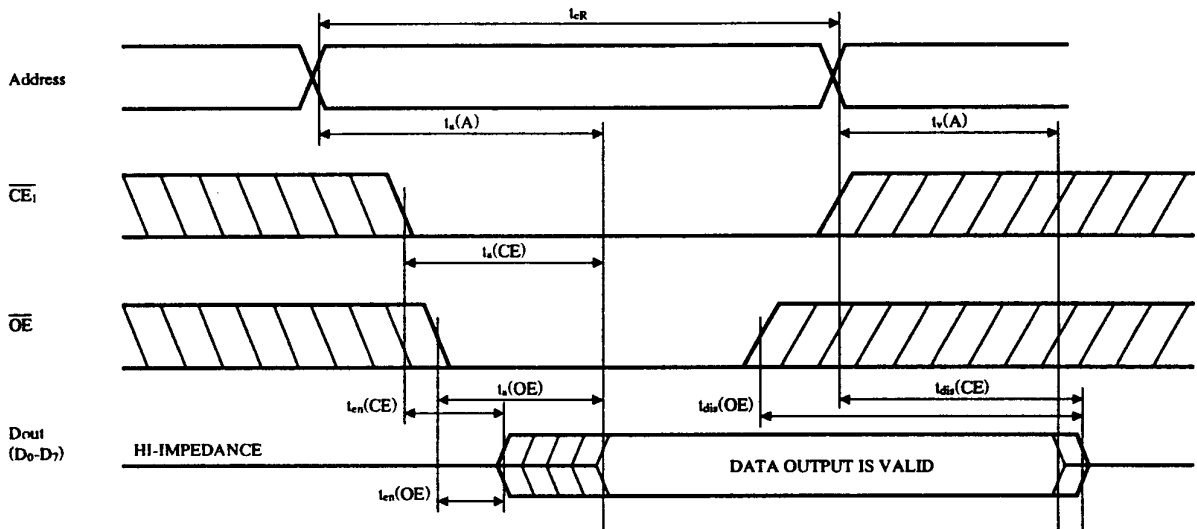   4) Output Load   : 1TTL+C_L (100pF) (including scope and jig capacitance)

9.2.1 Read Cycle

$(V_{CC}=4.5\sim5.5V, V_{PP}=0.0\sim1.5V, Ta=0\sim60°C)$

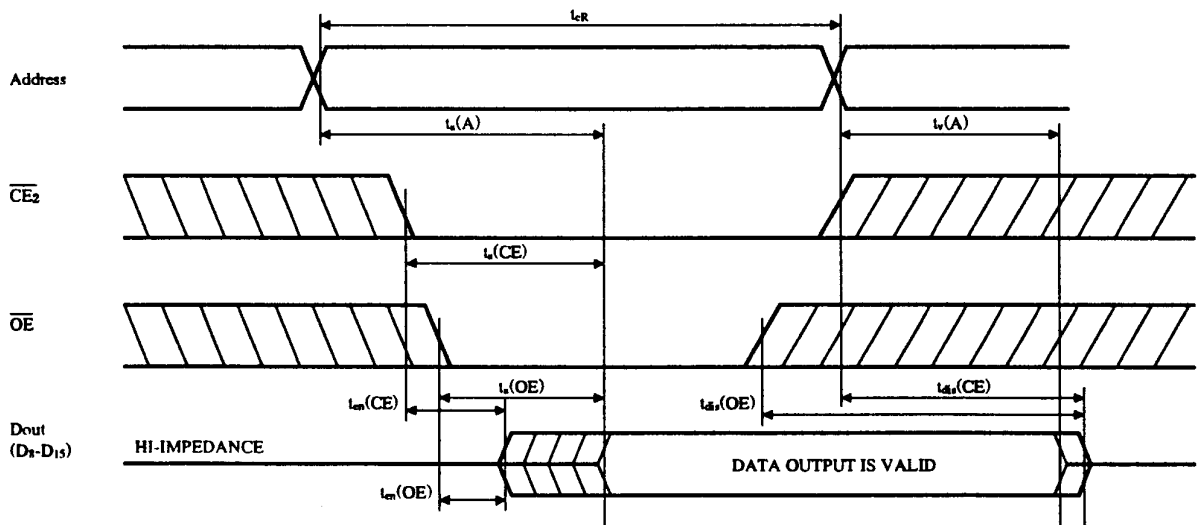| PARAMETER	SYMBOL	SYMBOL (PCMCIA)	Min.	Max.	UNIT
Read Cycle Time	t_{AVAV}	t_{cR}	200	—	ns
Address Access Time	t_{AVQV}	$t_a(A)$	—	200	
Card Enable Access Time	t_{ELQV}	$t_a(CE)$	—	200	
Output Enable Access Time	t_{GLQV}	$t_a(OE)$	—	100	
Output Disable Time from $\overline{CE}$ *	t_{EHQV}	$t_{dis}(CE)$	—	90	
Output Disable Time from $\overline{OE}$ *	t_{GHQZ}	$t_{dis}(OE)$	—	90	
Output Enable Time from $\overline{CE}$	t_{ELQX}	$t_{en}(CE)$	5	—	
Output Enable Time form $\overline{OE}$	t_{GLQX}	$t_{en}(OE)$	5	—	
Data Valid from Add Change		$t_v(A)$	0	—	

* Time until output becomes floating. (The output voltage is not defined.)

○Read CYCLE (1) ($\overline{CE}_2 = V_{IH}$ Fixed), 8bits Output

Address

t_{cR}

$t_a(A)$

$t_v(A)$

$\overline{CE}_1$

$t_a(CE)$

$\overline{OE}$

$t_a(OE)$

$t_{dis}(OE)$

$t_{dis}(CE)$

$t_{en}(CE)$

Dout
(D_0-D_7)

HI-IMPEDANCE

DATA OUTPUT IS VALID

$t_{en}(OE)$

Note) 1. $\overline{WE}$ = "HIGH", during a read cycle.

2. Either "HIGH" or "LOW" in diagonal areas.

3. The output data becomes valid when last interval, t_a (A), t_a (CE) or t_a (CE) have concluded.

○Read Cycle (2) ($\overline{CE}_1 = V_{IH}$ Fixed), 8Bits Output

Address

t_{cR}

$t_a(A)$

$t_v(A)$

$\overline{CE}_2$

$t_a(CE)$

$\overline{OE}$

$t_a(OE)$

$t_{dis}(OE)$

$t_{dis}(CE)$

$t_{en}(CE)$

Dout
(D_8-D_{15})

HI-IMPEDANCE

DATA OUTPUT IS VALID

$t_{en}(OE)$

Note) 1. $\overline{WE}$ = "HIGH", during a read cycle.

2. Either "HIGH" or "LOW" in diagonal areas.

3. The output data becomes valid when last interval, t_a (A), t_a (CE) or t_a (CE) have concluded.

○Read Cycle (3), 16Bits Output
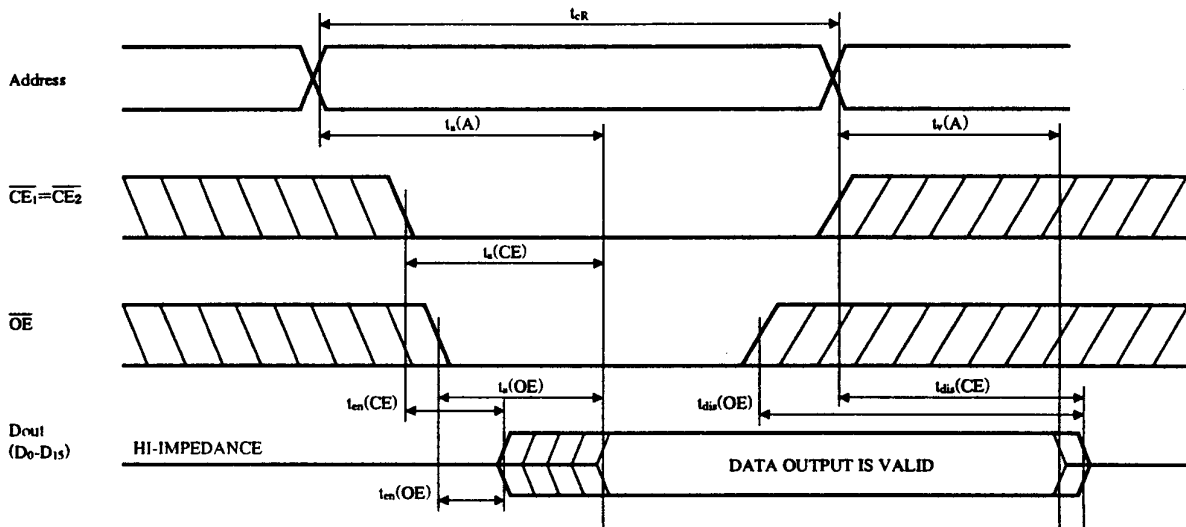
Note) 1. $\overline{WE}=$"HIGH", during a read cycle.

2. Either "HIGH" or "LOW" in diagonal areas.

3. Change $\overline{CE_1}$ and $\overline{CE_2}$ at the same time.

4. The output data becomes valid when last interval, $t_a(A)$, $t_a(CE)$ or $t_a(CE)$ have concluded.

10. Programming Operation

10.1 DC Characteristics
$(V_{CC}=4.5\sim5.5V, V_{PP}=4.5\sim5.5V/11.4\sim12.6V, Ta=0\sim60℃)$

PARAMETER		SYMBOL	Min.	Max.	UNIT	CONDITION	
V_{PP1}, V_{PP2} operating Voltage	Read	V_{PPL}	0	1.5	V		
	Program	V_{PPH}	4.5	5.5		$V_{PP}=4.5\sim5.5V$	
			11.4	12.6		$V_{PP}=11.4\sim12.6V$	
V_{PP1}, V_{PP2} operating Current (×16 Mode)	Read	I_{SB2}	—	1.6	mA	Input open	
	Program	I_{PP}	—	45		RMS	$V_{PP}=4.5\sim5.5V$
			—	20			$V_{PP}=11.4\sim12.6V$
V_{CC} operating Current	Standby	I_{SB1}	—	2		Input open	×16 Mode
	Program	I_{CC}	—	75		RMS	
Input Voltage		V_{IL}	−0.3	1.5	V		
		V_{IH}	3.5	$V_{CC}+0.3$			
Output Voltage During Verify		V_{OL}	—	0.4		$I_{OL}=4mA$	
		V_{OH}	$V_{CC}-0.5$	—		$I_{OH}=-2mA$	

Note) 1. Power on V_{CC} before power on V_{CC}, power off V_{CC} after power off V_{PP}.

2. Keep V_{PP} including its overshoot, below 13V.

3. Card insertion or removal while applying $V_{PP}=12V$ may cause a loss of integrity.

4. Do not turn on or turn off during $\overline{CE}=$"LOW".

5. If V_{IH} goes above $V_{CC}+0.3V$, normal operation is not assured.

10.2 AC Characteristics (V_{CC}=4.5~5.5V, V_{PP}=4.5~5.5V/11.4~12.6V, Ta=0~60℃)

Testing Conditions:

1) Input Pulse Level　　　　　　　　　　　: 0.8~3.5V

2) Input Rise/Fall Time　　　　　　　　　: 10ns

3) Input/Output Timing Reference Level　: 1.5V

4) Output Load　　　　　　　　　　　　　: 1TTL＋C_L (100pF) (including scope and jig capacitance)

10.2.1 Program Cycle

$\overline{WE}$ Controlled　　　　　　　　　　　　　　　　(V_{CC}=4.5~5.5V, V_{PP}=4.5~5.5V/11.4~12.6V, Ta=0~60℃)

PARAMETER		SYMBOL	SYMBOL (PCMCIA)	Min.	Max.	UNIT
Write Cycle Time		t_{AVAV}	t_{cW}	200	—	ns
Address Setup Time		t_{AVWL}	t_{su} (A)	20	—	
Write Recovery Time		t_{WHAX}	t_{rec} (WE)	30	—	
Data Setup Time for $\overline{WE}$		t_{DVWH}	t_{su} (D-WEH)	60	—	
Data Hold Time		t_{WHDX}	t_h (D)	30	—	
Write Recovery Before Read		t_{WHGL}		10	—	
Card Enable Setup time for $\overline{WE}$		t_{ELWH}	t_{su} (CE-WEH)	140	—	
Address Setup for $\overline{WE}$		t_{AVWH}	t_{su} (A-WEH)	140	—	
Card Enable Hold Time		t_{WHEH}		15	—	
Write Pulse Width		t_{WLWH}	t_W (WE)	120	—	
Write Pulse Width High		t_{WHWL}	t_W (WEH)	30	—	
$\overline{WE}$ High to RDY/$\overline{BSY}$ Going Low		t_{WHRL}		—	150	
Duration of write operation	V_{PP}=4.5~5.5V	t_{WHQV1}		6.5	—	μs
	V_{PP}=11.4~12.6V			4.8	—	
V_{PP} Setup to $\overline{WE}$ Going High		t_{VPWH}		100	—	ns
V_{PP} Hold from Valid SRD, RDY/$\overline{BSY}$ High		t_{QVVL}		0	—	

$\overline{CE}$ Controlled　　　　　　　　　　　　　　　　(V_{CC}=4.5~5.5V, V_{PP}=4.5~5.5V/11.4~12.6V, Ta=0~60℃)

PARAMETER		SYMBOL	SYMBOL (PCMCIA)	Min.	Max.	UNIT
Write Cycle Time		t_{AVAV}	t_{cW}	200	—	ns
Address Setup Time		t_{AVEL}	t_{su} (A)	20	—	
Write Recovery Time		t_{EHAX}	t_{rec} (CE)	30	—	
Data Setup Time for $\overline{CE}$		t_{DVEH}	t_{su} (D-CEH)	60	—	
Data Hold Time		t_{EHDX}	t_h (D)	30	—	
Write Recovery Before Read		t_{EHGL}		10	—	
Write Enable Setup time for $\overline{CE}$		t_{WLEH}	t_{su} (WE-CEH)	140	—	
Address Setup for $\overline{CE}$		t_{AVEH}	t_{su} (A-CEH)	140	—	
Write Enable Hold Time		t_{EHWH}		0	—	
Write Pulse Width		t_{ELEH}	t_W (CE)	120	—	
Write Pulse Width High		t_{EHEL}	t_W (CEH)	30	—	
$\overline{WE}$ High to RDY/$\overline{BSY}$ Going Low		t_{EHRL}		—	150	
Duration of write operation	V_{PP}=4.5~5.5V	t_{EHQV1}		6.5	—	μs
	V_{PP}=11.4~12.6V			4.8	—	
V_{PP} Setup to $\overline{WE}$ Going High		t_{VPEH}		100	—	ns
V_{PP} Hold from Valid SRD, RDY/$\overline{BSY}$ High		t_{QVVL}		0	—	

1. Set $\overline{CE_1}$, $\overline{CE_2}$, $\overline{OE}$ and $\overline{WE}$ "HIGH", when V_{PP} changes from V_{PPL} to V_{PPH} or vice versa.

○Program Cycle ($\overline{WE}$ Controlled)
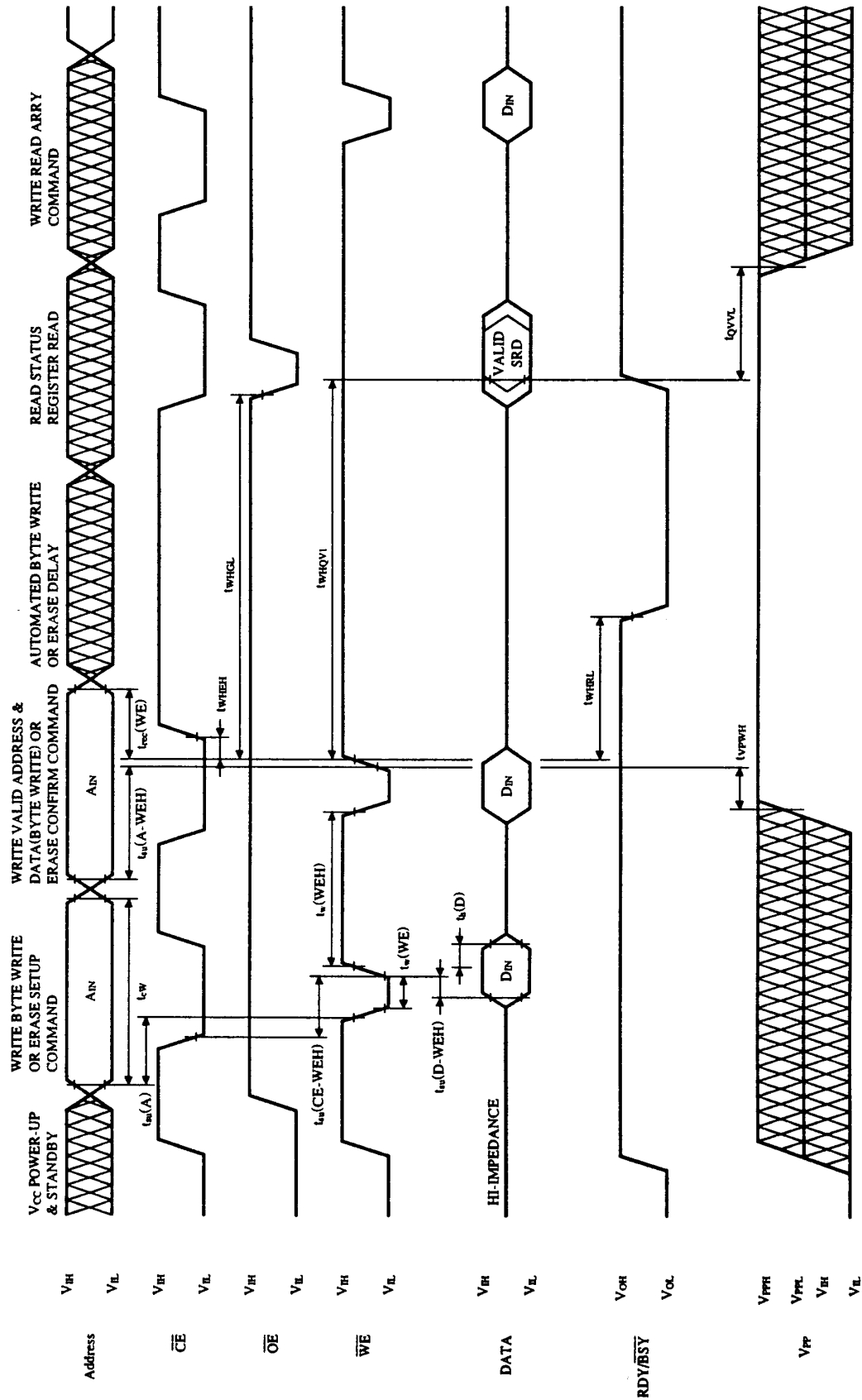
Note) While the data signal is in output mode, do not apply an opposite phase signal.

○Program Cycle (CE Controlled)
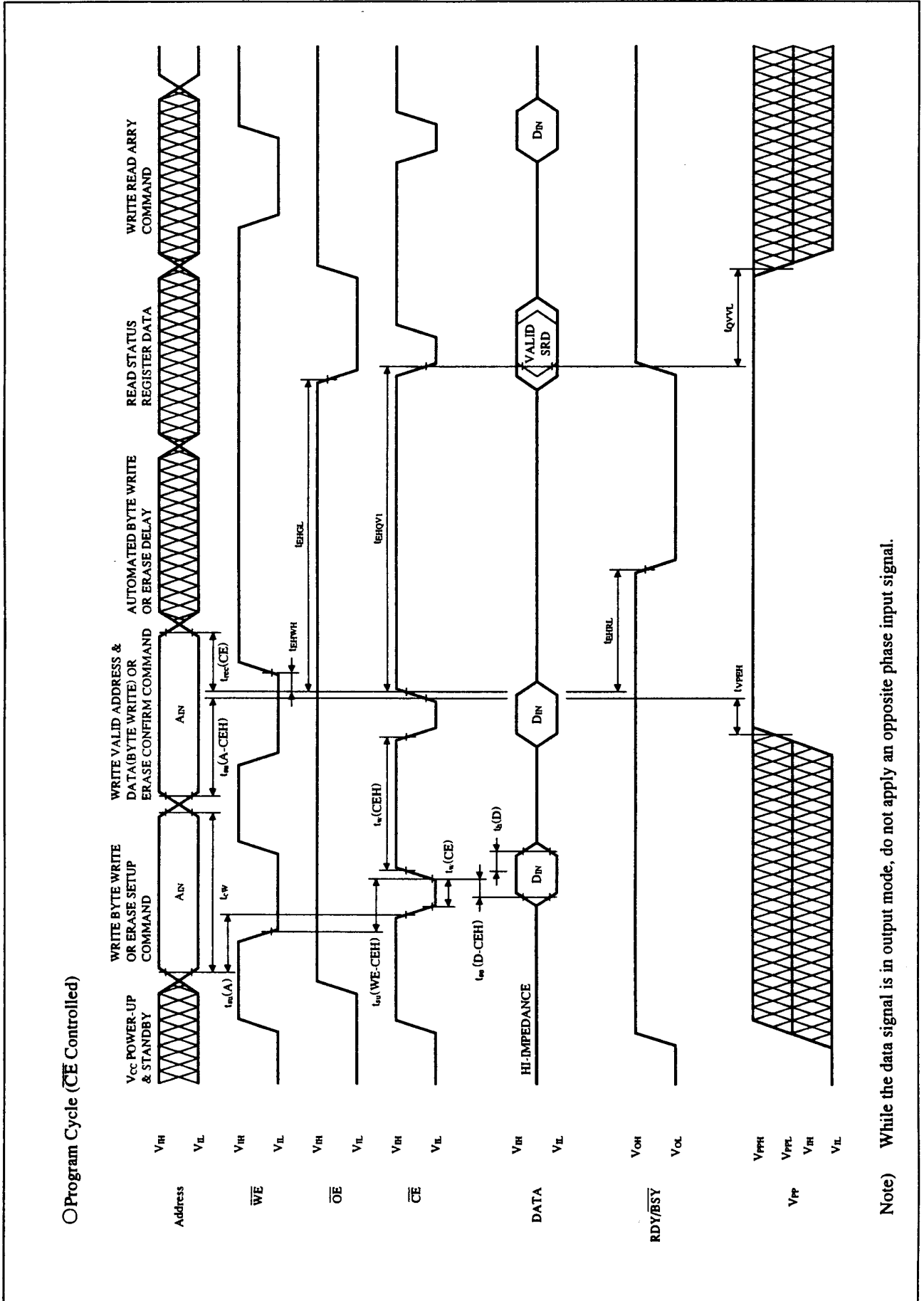
Note)   While the data signal is in output mode, do not apply an opposite phase input signal.

11. Erase Operation

11.1 DC Charactristics
$(V_{CC}=4.5\sim5.5V, V_{PP}=4.5\sim5.5V/11.4\sim12.6V, Ta=0\sim60°C)$

PARAMETER		SYMBOL	Min.	Max.	UNIT	CONDITION	
V_{PP1}, V_{PP2} Operating Voltage	Read	V_{PPL}	0	1.5	V		
	Program	V_{PPHE}	4.5	5.5		$V_{PP}=4.5\sim5.5V$	
			11.4	12.6		$V_{PP}=11.4\sim12.6V$	
V_{PP1}, V_{PP2} Operating Current (×16 Mode)	Standby	I_{SB2}	—	1.6	mA	I/O open	
	Erase	I_{PP}	—	45		RMS	$V_{PP}=4.5\sim5.5V$
			—	20			$V_{PP}=11.4\sim12.6V$
	Erase Suspend	I_{PPS}	—	1.6		$\overline{CE}_1$, $\overline{CE}_2=V_{IH}$, RMS	
V_{CC} Operating Current (×16 Mode)	Standby	I_{SB1}	—	2.0		I/O open	
	Erase	I_{CCE}	—	75		RMS	
	Erase Suspend	I_{CCES}	—	22		$\overline{CE}_1$, $\overline{CE}_2=V_{IH}$, RMS	
Input Voltage		V_{IL}	−0.3	1.5	V		
		V_{IH}	3.5	$V_{CC}+0.3$			
Output Voltage During Verify		V_{OL}	—	0.4		$I_{OL}=4mA$	
		V_{OH}	$V_{CC}-0.5$	—		$I_{OH}=-2mA$	

Note) Power on V_{CC} before power on V_{CC}, power off V_{CC} after power off V_{PP}. Keep V_{PP} including its overshoot, below 13V Card insertion or removal while applying $V_{PP}=12V$ may cause a loss of integrity. Do not turn on or turn off during $\overline{CE}=$ "LOW".

If V_{IH} goes above $V_{CC}+0.3V$, normal operation is not assured.

11.2 AC Characteristics $(V_{CC}=4.5\sim5.5V, V_{PP}=4.5\sim5.5V/11.4\sim12.6V, Ta=0\sim60°C)$

Testing Conditions:
1) Input Pulse Level : $0.8\sim3.5V$
2) Input Rise/Fall Time : 10ns
3) Input/Output Timing Reference Level : 1.5V
4) Output Load : $1TTL+C_L$ (100pF) (including scope and jig capacitance)

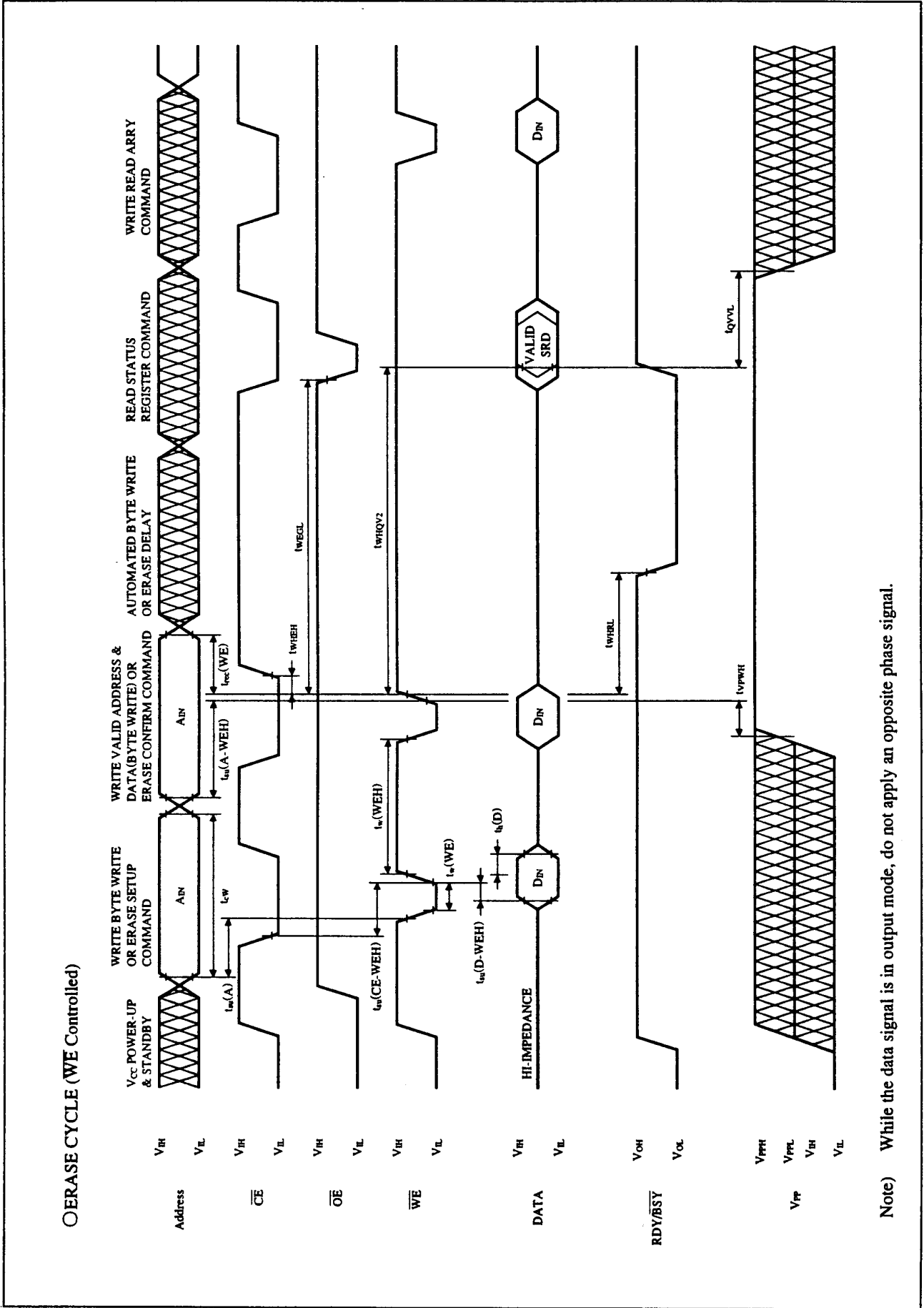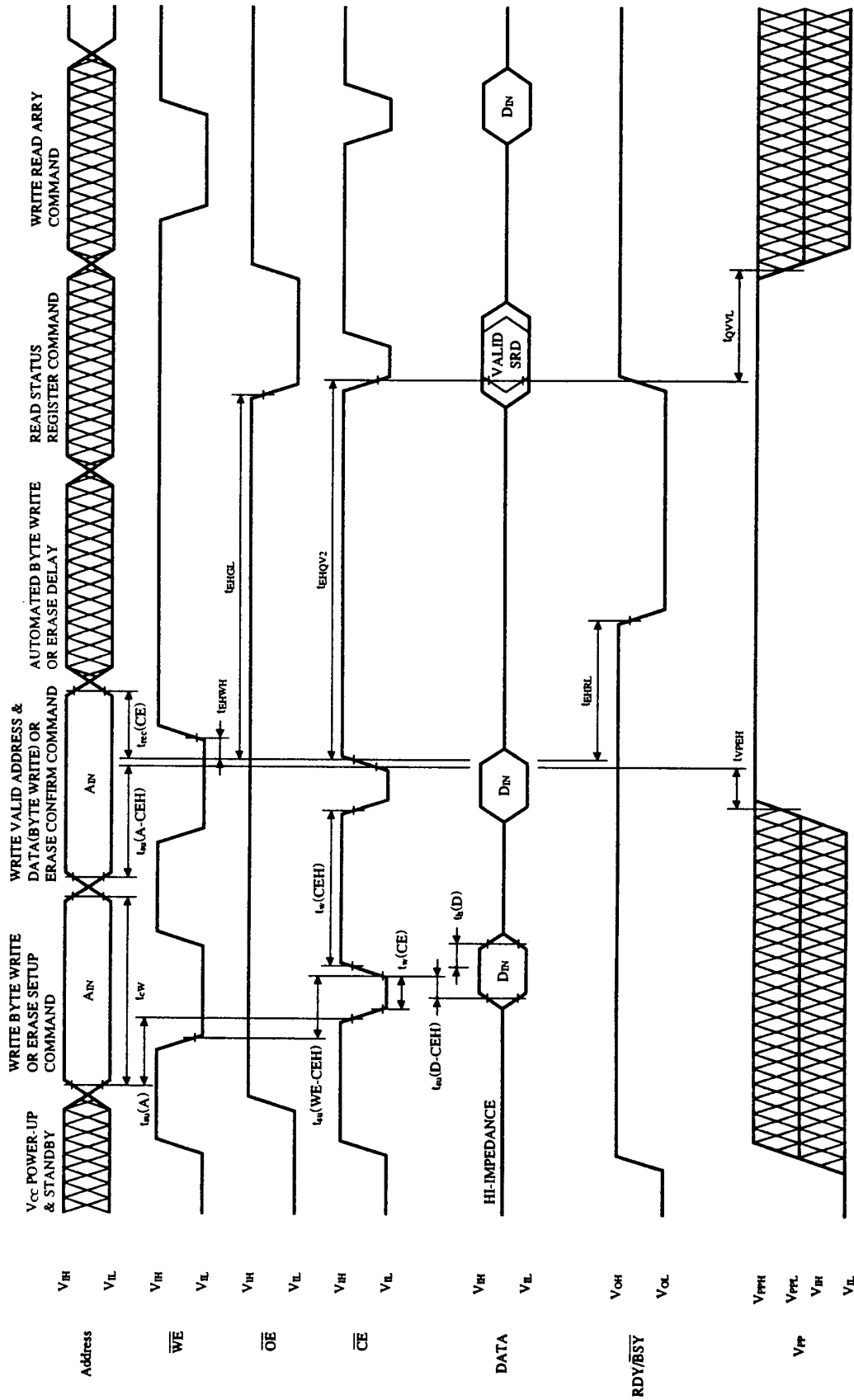#### 11.2.1 Erase Cycle
$\overline{WE}$ Controlled $(V_{CC}=4.5\sim5.5V, V_{PP}=4.5\sim5.5V/11.4\sim12.6V, Ta=0\sim60°C)$

PARAMETER		SYMBOL	SYMBOL (PCMCIA)	Min.	Max.	UNIT
Write Cycle Time		t_{AVAV}	t_{cw}	200	—	ns
Address Setup Time		t_{AVWL}	t_{su} (A)	20	—	
Write Recovery Time		t_{WHAX}	t_{rec} (WE)	30	—	
Data Setup Time for $\overline{WE}$		t_{DVWH}	t_{su} (D-WEH)	60	—	
Data Hold Time		t_{WHDX}	t_h (D)	30	—	
Write Recovery Before Read		t_{WHGL}		10	—	
Card Enable Setup time for $\overline{WE}$		t_{ELWH}	t_{su} (CE-WEH)	140	—	
Address Setup for $\overline{WE}$		t_{AVWH}	t_{su} (A-WEH)	140	—	
Card Enable Hold Time		t_{WHEH}		15	—	
Write Pulse Width		t_{WLWH}	t_w (WE)	120	—	
Write Pulse Width High		t_{WHWL}	t_w (WEH)	30	—	
$\overline{WE}$ High to RDY/$\overline{BSY}$ Going Low		t_{WHRL}		—	150	
Duration of Erase operation	$V_{PP}=4.5\sim5.5V$	t_{WHQV2}		0.9	—	s
	$V_{PP}=11.4\sim12.6V$			0.3	—	
V_{PP} Setup to $\overline{WE}$ Going High		t_{VPWH}		100	—	ns
V_{PP} Hold from Valid SRD, RDY/$\overline{BSY}$ High		t_{QVVL}		0	—	

$\overline{CE}$ Contorolled   (V_{CC}=4.5~5.5V, V_{PP}=4.5~5.5V/11.4~12.6V, Ta=0~60°C)

PARAMETER		SYMBOL	SYMBOL (JEIDA)	Min.	Max.	UNIT
Write Cycle Time		t_{AVAV}	t_{cw}	200	—	ns
Address Setup Time		t_{AVEL}	t_{su} (A)	20	—	
Write Recovery Time		t_{EHAX}	t_{rec} (CE)	30	—	
Data Setup Time for $\overline{CE}$		t_{DVEH}	t_{su} (D-CEH)	60	—	
Data Hold Time		t_{EHDX}	t_{h} (D)	30	—	
Write Recovery Before Read		t_{EHGL}		10	—	
Write Enable Setup time for $\overline{CE}$		t_{WLEH}	t_{su} (WE-CEH)	140	—	
Address Setup for $\overline{CE}$		t_{AVEH}	t_{su} (A-CEH)	140	—	
Write Enable Hold Time		t_{EHWH}		0	—	
Write Pulse Width		t_{ELEH}	t_{w} (CE)	120	—	
Write Pulse Width High		t_{EHEL}	t_{w} (CEH)	30	—	
$\overline{WE}$ High to RDY/$\overline{BSY}$ Going Low		t_{EHRL}		—	150	
Duration of Erase operation	V_{PP}=4.5~5.5V	t_{EHQV2}		0.9	—	s
	V_{PP}=11.4~12.6V	t_{EHQV2}		0.3	—	
V_{PP} Setup to $\overline{WE}$ Going High		t_{VPEH}		100	—	ns
V_{PP} Hold from Valid SRD, RDY/$\overline{BSY}$ High		t_{QVVL}		0	—	

1. Set $\overline{CE_1}$, $\overline{CE_2}$, $\overline{OE}$ and $\overline{WE}$ "HIGH", when V_{PP} changes from V_{PPL} to V_{PPH} or vice versa.

○ERASE CYCLE (WE Controlled)

	V_{CC} POWER-UP & STANDBY	WRITE BYTE WRITE OR ERASE SETUP COMMAND	WRITE VALID ADDRESS & DATA(BYTE WRITE) OR ERASE CONFIRM COMMAND	AUTOMATED BYTE WRITE OR ERASE DELAY	READ STATUS REGISTER COMMAND	WRITE READ ARRY COMMAND

Signals: Address, $\overline{CE}$, $\overline{OE}$, $\overline{WE}$, DATA, RDY/$\overline{BSY}$, V_{PP}

Levels: V_{IH}, V_{IL}, V_{OH}, V_{OL}, V_{PPH}, V_{PPL}

A_{IN}, D_{IN}, VALID SRD, HI-IMPEDANCE

Timing parameters: $t_{AS}(A)$, t_W, $t_{AH}(A\text{-}WEH)$, $t_{rec}(WE)$, t_{WHEH}, t_{WEGL}, t_{WHQV2}, $t_{ELS}(CE\text{-}WEH)$, $t_W(WEH)$, $t_{AS}(WE)$, $t_{AH}(D)$, $t_{DS}(D\text{-}WEH)$, t_{WHRL}, t_{VPWH}, t_{QVVL}

Note) While the data signal is in output mode, do not apply an opposite phase signal.

ERASE CYCLE (CE Controlled)

Vcc POWER-UP & STANDBY

WRITE BYTE WRITE OR ERASE SETUP COMMAND

WRITE VALID ADDRESS & DATA(BYTE WRITE) OR ERASE CONFIRM COMMAND

AUTOMATED BYTE WRITE OR ERASE DELAY

READ STATUS REGISTER COMMAND

WRITE READ ARRY COMMAND

Address

$\overline{WE}$

$\overline{OE}$

$\overline{CE}$

DATA

RDY/$\overline{BSY}$

V_{PP}

A_{IN}

A_{IN}

D_{IN}

D_{IN}

D_{IN}

VALID SRD

HI-IMPEDANCE

$t_{AH}(A)$

t_{CW}

$t_{AH}(WE\text{-}CEH)$

$t_{AS}(D\text{-}CEH)$

$t_{AS}(A\text{-}CEH)$

$t_{rec}(CE)$

t_{EHFVH}

$t_{W}(CEH)$

$t_{W}(CE)$

$t_{H}(D)$

t_{EHGL}

t_{EHQV2}

t_{EHRL}

t_{VPEH}

t_{QVVL}

V_{IH} V_{IL}

V_{IH} V_{IL}

V_{IH} V_{IL}

V_{IH} V_{IL}

V_{IH} V_{IL}

V_{OH} V_{OL}

V_{PPH} V_{PPL} V_{IH} V_{IL}

Note) While the data signal is in output mode, do not apply an opposite phase signal.

12. Block Erase and Data Write Characteristics

$(V_{CC}=4.5\sim5.5V, V_{PP}=4.5\sim5.5V/11.4\sim12.6V, Ta=0\sim60^\circ C)$

PARAMETER		Min.	Typ.	Max.	UNIT
Block Pair Erase Time	$V_{PP}=4.5\sim5.5V$	—	1.1	10	
	$V_{PP}=11.4\sim12.6$	—	1.0	10	s
Block Pair Write Time	$V_{PP}=4.5\sim5.5V$	—	0.5	2.1	
	$V_{PP}=11.4\sim12.6$	—	0.4	2.1	

13. Voltage Timing (Ta=25°C)

$3.5V < V_{IH} < V_{CC}+0.3$
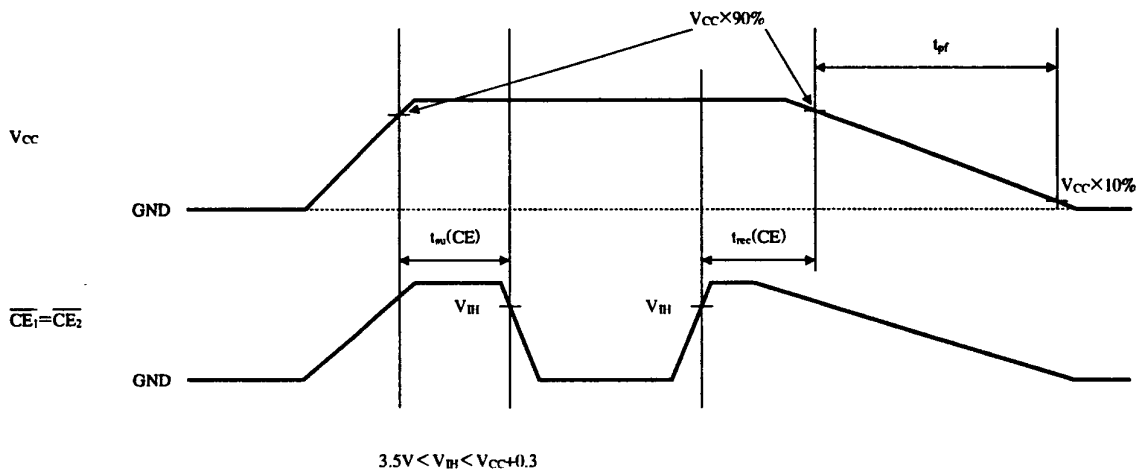
PARAMETER	SYMBOL	Min.	Max.	UNIT
$\overline{CE}$ Setup Time	t_{su} (CE)	4.0	—	ms
$\overline{CE}$ Recovery Time	t_{rec} (CE)	1.0	—	μs
V_{CC} Falling Time	t_{pf}	3.0	300	ms

Note)   1. When V_{CC} (4.5～5.5V) is applied to the memory card and you are inserting or removing the card, $\overline{CE}_1$, $\overline{CE}_2$ should both be high-impedance. At such a time, other signal line should also be hi-impedance. After inserting the memory card, do not access it during the $\overline{CE}$ setup time (minimum of 4ms).

(During this time, neither $\overline{CE}_1$ nor $\overline{CE}_2$= "LOW" .)

2. When V_{CC} is turn on, if the condition (for example, V_{CC} rising time. etc) is not sufficient to as specified, it is possible that device's Status Register is not cleared or device not becomes to Read Array Mode. To prevent these, it is recommended that using software command, reset the Status Register or set the device to Read Array Mode.

ex.

Reset the Status Register   50H (5050H)

Set to Read Array Mode   FFH (FFFFH)

14. Attribute Memory

The attribute memory holds the attribute information of the card such as the type of card, bit configuration, speed and so on.

EEPROM Model

Card has 2k bytes of EEPROM attribute memory. To read the attribute memory, set $\overline{REG}$ = "LOW" and perform a read with the same access timming as common memory read.

For this operation, access time is 300ns maximum. To allow 2k bytes of attribute memory, even addresses from 0 to 4096 are reserved. Since only the even-numbered bytes are used, reading odd-numbered bytes will result in invalid data.

Note) We have another type of attribute memory as follows,

No EEPROM Model. (Model no.ID244H02 : 5 bytes device informations in even address 0 to 8, read only in card's control circuit, with the same access timming as common memory read.

14.1 Attribute Memory Read/Write Function Chart

$\overline{CE_1}$	$\overline{CE_2}$	A_0	$\overline{WE}$	$\overline{OE}$	$\overline{REG}$	MODE	$D_0 \sim D_7$	$D_8 \sim D_{15}$	STAATUS
H	H	X	X	X	X		High-Z	High-Z	Standby
L	H	L	H	L	L	Read (×8)	D_0 (even byte)	High-Z	Byte Access
L	H	H	H	L	L		High-Z	High-Z	Standby
L	L	X	H	L	L	Read (×8)	D_0 (even byte)	High-Z	Byte Access
H	L	X	H	L	L		High-Z	High-Z	Standby
L	H	L	L	H	L	Write (×8)	D_1 (even byte)	× × ×	Byte Access
L	H	H	L	H	L		×××	× × ×	Standby
L	L	X	L	H	L	Write (×8)	D_1 (even byte)	× × ×	Byte Access
H	L	X	L	H	L		×××	× × ×	Standby
L	X	X	H	L	L	Attribute Memory Address 0~8	D_0	High-Z	Byte Access

H : High   L : Low   X : High/Low not applicable
Di : Input Data   Do : Output Data   Hi-Z : High Impedance   × × × : Don't Care

Notes : 1) When the write protect switch is in protect-mode, the WP output signal is "HIGH" and write operations (including attribute memory) are not allowed.

2) A_0-A_{11} are attribute memory address. Addresses after A_{12} are not decoded, so care should be taken.

14.2 AC Characteristics (V_{CC} = 4.5V~5.5V, Ta = 0~60℃)

Testing Conditions

1) Input Pulse Level   : 0.8~3.5V

2) Input Rise/Fall Time   : 10ns

3) Input/Output Timing Reference Level   : 1.5V

4) Output Load Capacitance   : 1TTL+C_L (100pF)

(including scope and jig capacitance)

14.3 Attribute Memory Read Cycle

(V$_{CC}$=4.5~5.5V, Ta=0~60°C)

PARAMETER	SYMBOL	SYMBOL (PCMCIA)	Min.	Max.	UNIT
Read Cycle Time	t_{CR}	t_{cR}	300	—	
Address Access Time	t_{ACC}	t_a (A)	—	300	
Card Enable Access Time	t_{CE}	t_a (CE)	—	300	
Output Enable Access Time	t_{OE}	t_a (OE)	—	150	
Output Disable Time from $\overline{CE}$		t_{dis} (CE)	—	100	ns
Output Disable Time from $\overline{OE}$	t_{DF}	t_{dis} (OE)	—	100	
Output Enable Time from $\overline{CE}$		t_{en} (CE)	5	—	
Output Enable Time from $\overline{OE}$		t_{en} (OE)	5	—	
Data Valid from Add Change	t_{OH}	t_v (A)	0	—	

○ Attribute Memory Read Cycle
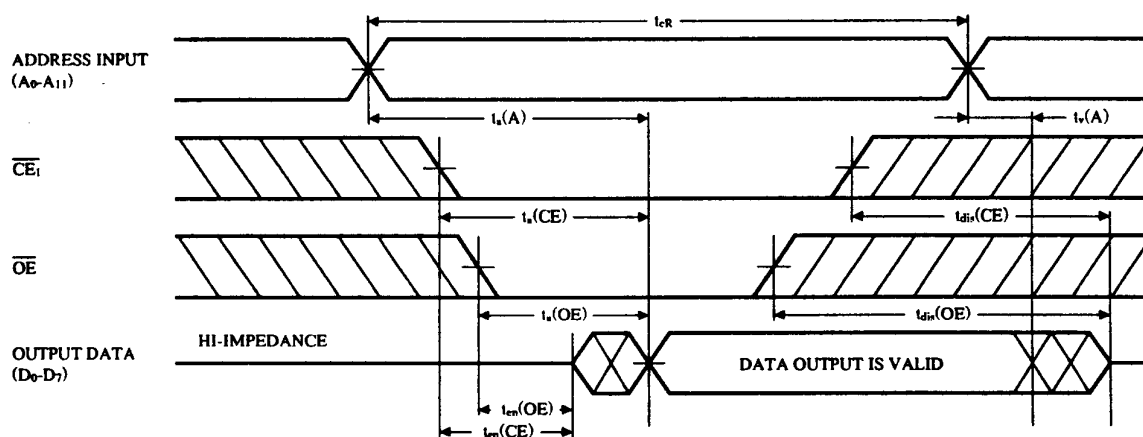
Note： 1. To read attribute memory, $\overline{REG}$="LOW", $\overline{WE}$="HIGH" and either $\overline{CE_2}$="LOW" or else $\overline{CE_2}$="HIGH" and A$_0$="LOW".

2. The output data becomes valid when last interval, t_a (A), t_a (CE) or t_a (OE) have concluded.
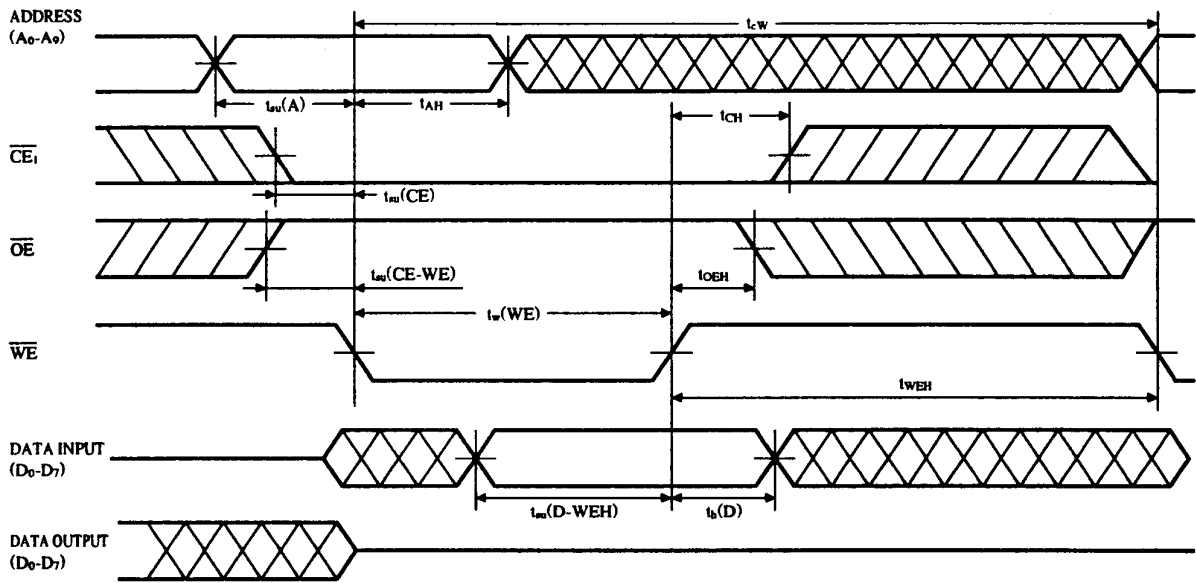
14.4 Attribute Memory Write Cycle

WE Controlled   (V_{CC}=4.5V~5.5V, Ta=0~60°C)

PARAMETER	SYMBOL	SYMBOL (PCMCIA)	Min.	Max.	UNIT
Write Cycle Time	t_{WC}	t_{cW}	10	—	ms
Write Pulse Width	t_{WP}	t_w (WE)	180	—	ns
Address Setup Time	t_{AS}	t_{su} (A)	10	—	
Data Setup Time for WE	t_{DS}	t_{su} (D-WEH)	100	—	
Card Enable Setup Time	t_{CES}	t_{su} (CE)	0	—	
Output Enable Setup Time	t_{OES}	t_{su} (OE-WE)	45	—	
Address Hold Time	t_{AH}		260	—	
Write Hold Time	t_{CH}		0	—	
Output Enable Hold Time	t_{OEH}		70	—	
WE HIGH Hold Time	t_{WEH}		9.9	—	ms
Data Hold Time	t_{DH}	t_h (D)	80	—	ns

CE Controlled   (V_{CC}=4.5V~5.5V, Ta=0~60°C)

PARAMETER	SYMBOL	SYMBOL (PCMCIA)	Min.	Max.	UNIT
Write Cycle Time	t_{WC}	t_{cW}	10	—	ms
Write Pulse Width	t_{WP}	t_w (CE)	210	—	ns
Address Setup Time	t_{AS}	t_{su} (A)	10	—	
Data Setup Time for CE	t_{DS}	t_{su} (D-CEH)	100	—	
Write Enable Setup Time	t_{WES}	t_{su} (WE)	0	—	
Output Enable Setup Time	t_{OES}	t_{su} (OE-CE)	45	—	
Address Hold Time	t_{AH}		260	—	
Write Hold Time	t_{WH}		0	—	
Output Enable Hold Time	t_{OEH}		70	—	
CE HIGH Hold Time	t_{CEH}		9.9	—	ms
Data Hold Time	t_{DH}	t_h (D)	80	—	ns

○Attribute Memory Write Cycle (WE Controlled)

○Attribute Memory Write Cycle (CE Controlled)
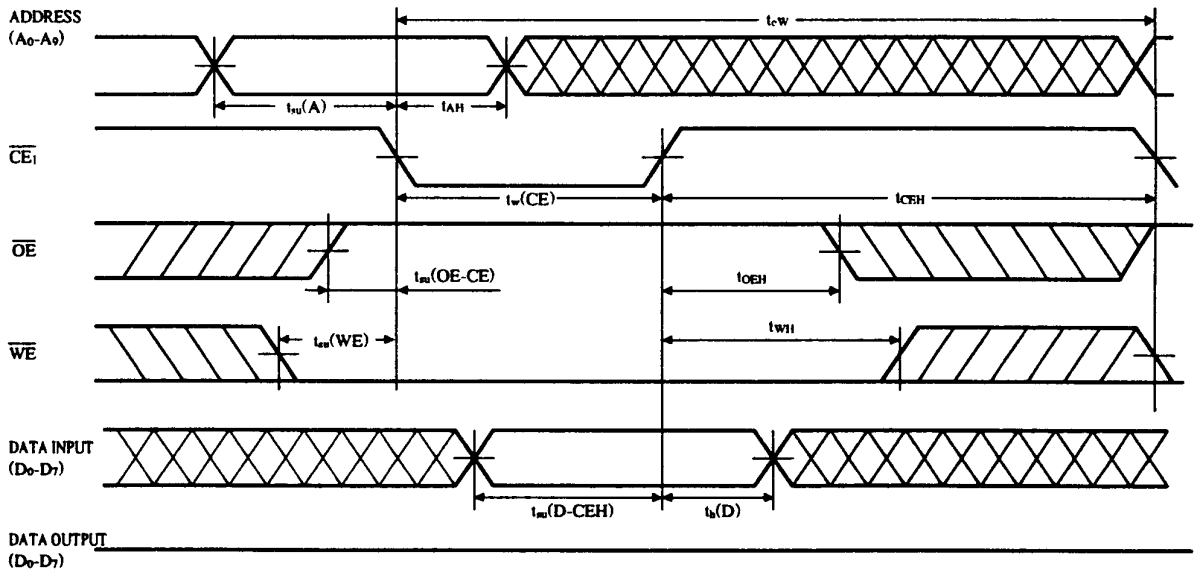
Note: 1. To write attribute memory, REG="LOW" and either CE₂="LOW" or else CE₂="HIGH" and A₀= "LOW"

15. Specification Changes

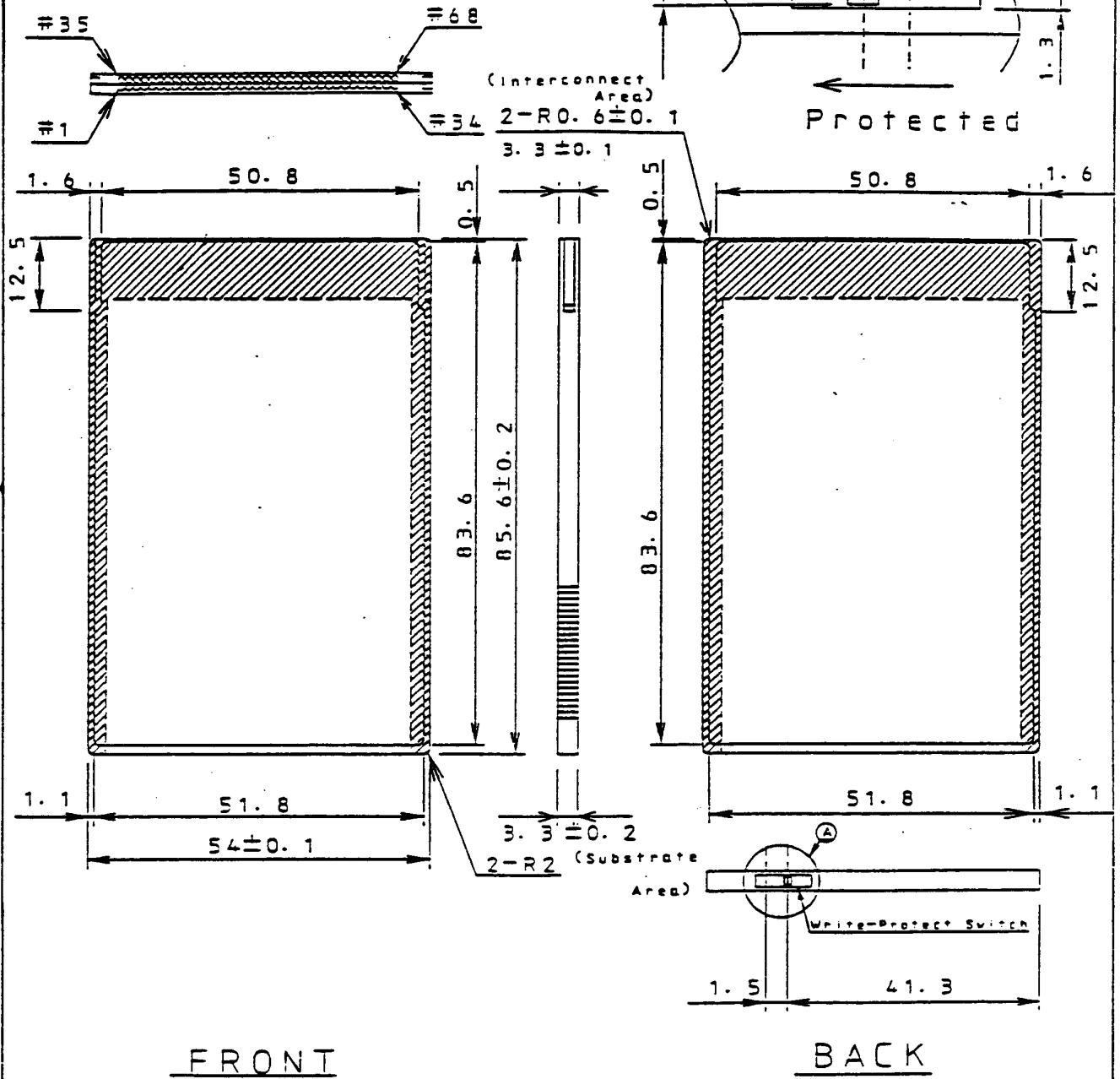Specifications may be changed upon discussion and agreement between both parties.

16. Othes Precautions

○ Permanent damage occures if the memory card is stressed beyond Absolute Maximum Ratings. Operation beyond the Recommended Operating Conditions is not recommended and extended exposure beyond the Recommended Operating Conditions may affect device reliability.

○ Writing to the memory card can be prevented by switching on the write protect switch on the end of the memory card.

○ Avoid allowing the memory card connectors to come in contact with metals and avoid touching the connectors, as the internal circuits can be damaged by static electricity.

○ Avoid storing in direct sunlight, high temperatures (do not place near heaters or radiators), high humidity and dusty areas.

○ Avoid subjecting the memory card to strong physical abuse. Dropping, bending, smashing or throwing the card can result in loss of function.

○ When the memory card is not being used, return it to its protective case.

○ Do not allow the memory card to come in contact with fire.

SHARP

(A) ENLARGEMENT OF THE
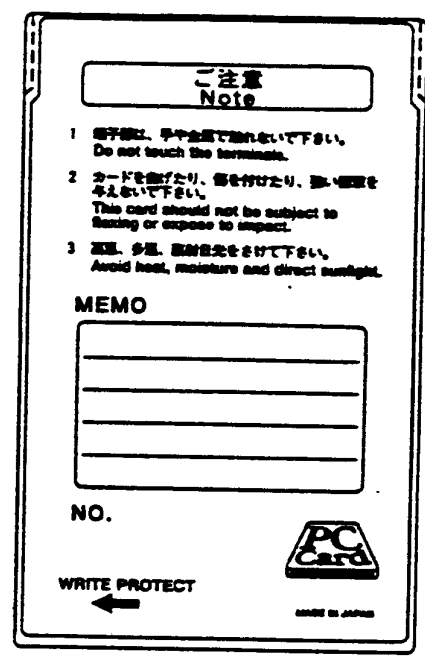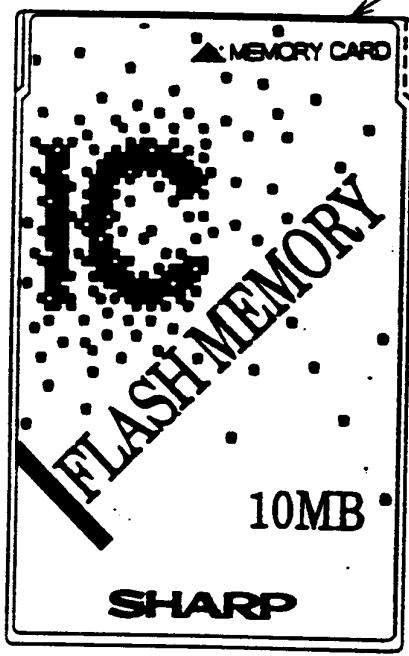WRITE-PROTECT SWITCH
back

17. External Diagrams

Protected

#35   #68

#1   #34

(Interconnect Area)
2-R0. 6±0. 1
3. 3±0. 1

1. 6   50. 8   0. 5   0. 5   50. 8   1. 6

12. 5   12. 5

⌀3. 6   ⌀5. 6±0. 2   ⌀3. 6

1. 1   51. 8   3. 3±0. 2   51. 8   1. 1

54±0. 1   (Substrate Area)

2-R2

(A)

Write-Protect Switch

1. 5   41. 3

FRONT   BACK

APPLICABLE		SCALE	UNIT	A			
MODEL		1/1	mm	A	CH. DATE	REVISE	CHANGE
THICKNESS		MATERIAL	FINISH		NAME	MEMORY. CARD	
						EXTERNAL DIAGRAM	
DATE	1994. 11. 16					PCMCIA Rel. 2. 0 TYPE:	
DESIGN	DRAW	TRACE	CHECK	APPROVE	Memory Card Business Project Team		
					TENRI IC GROUP	DRAWING NO.	IMC001-A102
					SHARP CORPORATION		

SHARP

19. EXTERNAL APPEARANCES

CONNECTOR SIDE

MEMORY CARD

IC FLASH MEMORY

10MB

SHARP

ご注意
Note

1 端子部は、手や金属で触れないで下さい。
  Do not touch the terminals.

2 カードを曲げたり、衝撃を与えたり、強い衝撃を
  与えないで下さい。
  This card should not be subject to
  flexing or expose to impact.

3 高温、多湿、直射日光をさけて下さい。
  Avoid heat, moisture and direct sunlight.

MEMO

NO.

WRITE PROTECT

PC Card

MADE IN JAPAN

Labeling position

FRONT PANEL

Part No	PA-R1-FF-045
Back Ground	DIC No. 290 Ver. 1
"IC" Text	DIC No. 906 Ver. 5
Other Characters

△MEMORY CARD
FLASH MEMORY
10MB
SHARP | DIC No. 651 |
| Design | Refer to above figure |

Frame Part No: FR-R1-10
    Color : Black

BACK PANEL

Part No	PA-R1-FR-001
Back Ground	DIC No. 290 Ver. 1
Text	Colorless
Characters On label	Black
Design	Refer to above figure

Label Size and Denotations

20   Model No

ID24X X X X
YWWAASSSS

Serial No.
User Code
Week of the Year
Last Digit of
A. D.
(199Y(Year)WW(Weeks))
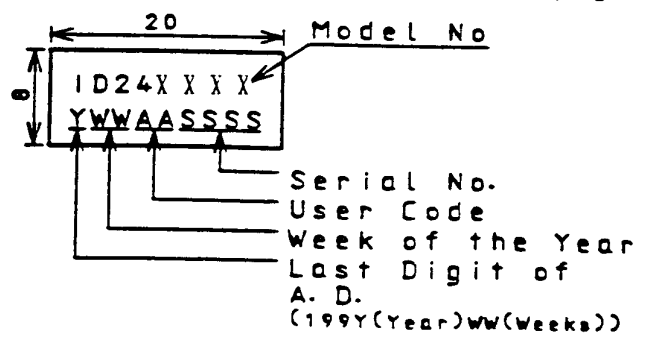
APPLICABLE MODEL		SCALE	UNIT				
	ID24XXXX	1/1	mm		CH. DATE	REVISE	CHARGE
THICKNESS	DEFFERENCE	MATERIAL	FINISH				
					NAME	ID24XXXX EXTENAL APPEARANCES	
DATE	1998. 7. 6						

SYSTEM MODULE BUSINESS P. T
INTEGRATED CIRCUITS GROUP
SHARP CORPORATION

DRAWING NO. IMC203-P100

SHARP

18. PACKING SPECIFICATION

ID24xxxx

Connector Side

IC Memory Card

Back Panel

Label the Model No. and Manufacturing No.

Note 4

Connector Side

Front Panel

IC Memory Card

Flexible Plastic Case

X25

Ⓐ Inner Carton
(25 pieces contained)

X4

Ⓒ Outer Carton
(100 pieces contained)

Ⓓ Outer Case
(400 pieces contained)

X4

Parts List

Parts	Parts Name					
A	Flexible Plastic Case					
B	Inner Carton (25 pieces contained)					
C	Outer Carton (100 pieces contained)					
D	Outer Case (400 pieces contained)					
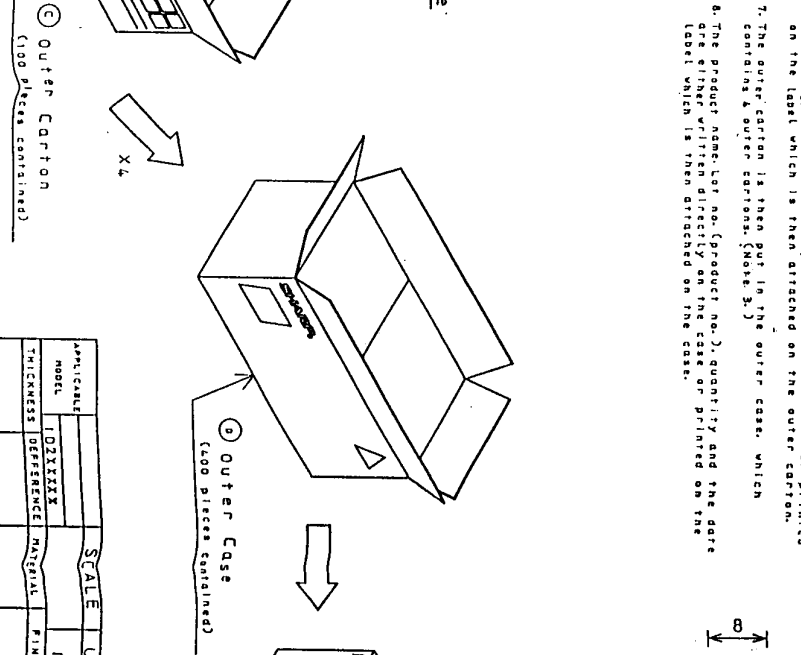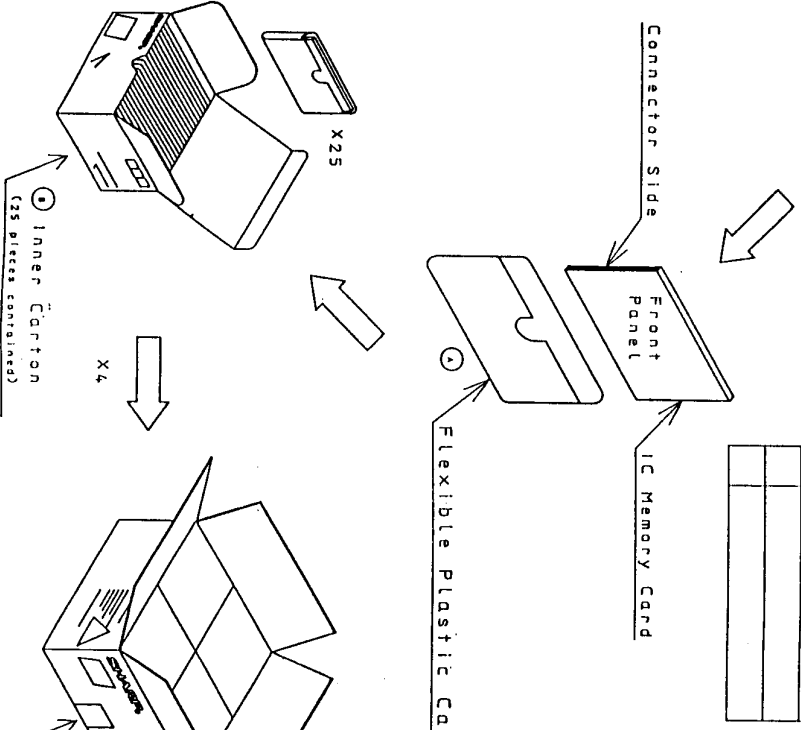
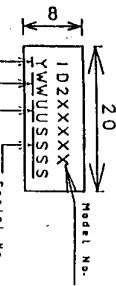## Packing Specification

1. Label the model No. and Manufuring No. on the back panel of the card.

2. Each memory card is contained in the flexible plastic case. (The front side of the card comes to the place where the card is released, and the connector side is placed against to this point, and the connector is not touched by finger, as shown in the figure.)

3. The inner carton contains 25 pieces of the card with the case. (Note 1.)

4. The product name, Lot no. (product no.), quantity and the date are either written directly on the inner carton, or printed on the label which is then attached on inner carton.

5. The outer carton contains 4 inner cartons. (Note 2.)

6. The product name, Lot no. (product no.), quantity and the date are either written directly on the outer carton, or printed on the label which is then attached on the outer carton.

7. The outer carton is then put in the outer case, which contains 4 outer cartons. (Note 3.)

8. The product name, Lot no. (product no.), quantity and the date are either written directly on the case or printed on the label which is then attached on the case.

Note 1. The least packing unit is 25 pieces, which is the number contained in the inner carton.

2. The space inside the outer carton is filled card boards.

3. The outer size of outer case may be used if there is not enough quantity to fill the normal outer case, which can contain 4 outer cartons.

4. Size of label and denotations are following. [unit:mm]

ID2XXXXX
YWWUUSSSS

8
20

Model No.

Serial No.

User Code

Week of the year

Lowest number of AC (1997 years WW the week)

APPLICABLE MODEL	THICKNESS	DIFFERENCE	MATERIAL	FINISH
ID2XXXXX				

DATE 1995.10.10

SCALE | UNIT | mm | A | CH.DATE | REVISE | CHARGE

NAME ID2XXXXX Packing Specification

SHARP CORPORATION

DRAWING NO. IMC025-J300

Series 2+, 10M, PCMCIA, Flash Card, ID244H01, Type 1